# **SPANSION™** Flash Memory

**Data Sheet** 



September 2003

This document specifies SPANSION<sup>™</sup> memory products that are now offered by both Advanced Micro Devices and Fujitsu. Although the document is marked with the name of the company that originally developed the specification, these products will be offered to customers of both AMD and Fujitsu.

# **Continuity of Specifications**

There is no change to this datasheet as a result of offering the device as a SPANSION<sup>™</sup> product. Future routine revisions will occur when appropriate, and changes will be noted in a revision summary.

# **Continuity of Ordering Part Numbers**

AMD and Fujitsu continue to support existing part numbers beginning with "Am" and "MBM". To order these products, please use only the Ordering Part Numbers listed in this document.

## For More Information

Please contact your local AMD or Fujitsu sales office for additional information about SPANSION<sup>™</sup> memory solutions.





# FLASH MEMORY

**CMOS** 

# 32M (2M imes 16) BIT Page Dual Operation

# MBM29PDS322TE<sub>10/11</sub> MBM29PDS322BE<sub>10/11</sub>

## **■ DESCRIPTION**

The MBM29PDS322TE/BE is 32M-bit, 1.8 V-only Flash memory organized as 2M words of 16 bits each. The device is offered in 63-ball FBGA package. This device is designed to be programmed in system with standard system 1.8 V Vcc supply. 12.0 V Vpp and 5.0 V Vcc are not required for write or erase operations. The device can also be reprogrammed in standard EPROM programmers.

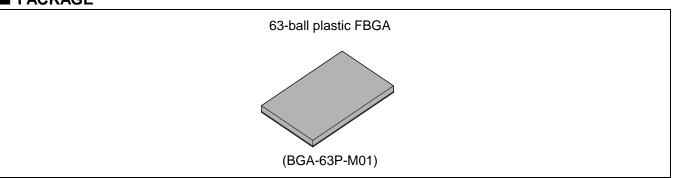
The device is organized into two banks, Bank 1 and Bank 2, which are considered to be two separate memory arrays for operations are concerned. It is the Fujitsu's standard 1.8 V only Flash memories with the additional capability of allowing a normal non-delayed read access from a non-busy bank of the array while an embedded write (either a program or an erase) operation is simultaneously taking place on the other bank.

(Continued)

## **■ PRODUCT LINE-UP**

Part No.	MBM29PD	S322TE/BE		
Fait No.	10	11		
Power Supply Voltage Vcc (V)	2.0 V	+0.2 V -0.2 V		
Max Random Address Access Time (ns)	100	115		
Max Page Address Access Time (ns)	40	50		
Max CE Access Time (ns)	100	115		
Max OE Access Time (ns)	35	45		

## **■ PACKAGE**





## (Continued)

The device provides truly high performance non-volatile Flash memory solution. The device offers fast page access times of 45 ns with random access times of 100 ns and 115 ns, allowing operation of high-speed microprocessors without wait states. To eliminate bus contention the device has separate chip enable  $(\overline{CE})$ , write enable  $(\overline{WE})$ , and output enable  $(\overline{OE})$  controls. The page size is 4 words.

The device is pin and command set compatible with JEDEC standard E<sup>2</sup>PROMs. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state-machine which controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from 5.0 V and 12.0 V Flash or EPROM devices.

The device is programmed by executing the program command sequence. This will invoke the Embedded Program Algorithm which is an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. Typically, each sector can be programmed and verified in about 0.5 seconds. Erase is accomplished by executing the erase command sequence. This will invoke the Embedded Erase Algorithm which is an internal algorithm that automatically preprograms the array if it is not already programmed before executing the erase operation. During erase, the device automatically time the erase pulse widths and verify proper cell margin.

A sector is typically erased and verified in 1.0 second. (If already completely preprogrammed.)

The device also features a sector erase architecture. The sector mode allows each sector to be erased and reprogrammed without affecting other sectors. The device is erased when shipped from the factory.

The device features single 1.8 V power supply operation for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations. A low  $V_{CC}$  detector automatically inhibits write operations on the loss of power. The end of program or erase is detected by  $\overline{Data}$  Polling of  $DQ_7$ , by the Toggle Bit feature on  $DQ_6$ , or the RY/ $\overline{BY}$  output pin. Once the end of a program or erase cycle has been completed, the device internally resets to the read mode.

The device also has a hardware RESET pin. When this pin is driven low, execution of any Embedded Program Algorithm or Embedded Erase Algorithm is terminated. The internal state machine is then reset to the read mode. The RESET pin may be tied to the system reset circuitry. Therefore, if a system reset occurs during the Embedded Program Algorithm or Embedded Erase Algorithm, the device is automatically reset to the read mode and will have erroneous data stored in the address locations being programmed or erased. These locations need re-writing after the Reset. Resetting the device enables the system's microprocessor to read the boot-up firmware from the Flash memory.

Fujitsu's Flash technology combines years of EPROM and E<sup>2</sup>PROM experience to produce the highest levels of quality, reliability, and cost effectiveness. The device memory electrically erase the entire chip or all bits within a sector simultaneously via Fowler-Nordhiem tunneling. The words are programmed one word at a time using the EPROM programming mechanism of hot electron injection.

#### **■ FEATURES**

- 0.23 μm Process Technology
- Simultaneous Read/Write Operations (Dual Bank)

Host system can program or erase in one bank, and then read immediately and simultaneously from the other bank with zero latency between read and write operations.

Read-while-erase

Read-while-program

### • High Performance Page Mode

45 ns maximum page access time (100 ns random access time)

4 words Page Size

## • Single 1.8 V Read, Program, and Erase

Minimized system level power requirements

#### Compatible with JEDEC-standard Commands

Use the same software commands as E<sup>2</sup>PROMs.

## • Compatible with JEDEC-standard World-wide Pinouts

63-ball FBGA (Package suffix: PBT)

• Minimum 100,000 Program/Erase Cycles

#### Sector Erase Architecture

Eight 4 K word and sixty-three 32 K word sectors in word mode

Any combination of sectors can be concurrently erased. Also supports full chip erase.

#### Boot Code Sector Architecture

T = Top sector

B = Bottom sector

#### HiddenROM Region

32 K word of HiddenROM, accessible through a new "HiddenROM Enable" command sequence Factory serialized and protected to provide a secure electronic serial number (ESN)

### • WP/ACC Input Pin

At V<sub>IL</sub>, allows protection of boot sectors, regardless of sector protection/unprotection status.

At V<sub>ACC</sub>, increases program performance.

# • Embedded Erase™\* Algorithms

Automatically pre-programs and erases the chip or any sector.

## Embedded Program<sup>™\*</sup> Algorithms

Automatically writes and verifies data at specified address.

#### • Data Polling and Toggle Bit Feature for Detection of Program or Erase Cycle Completion

#### Ready/Busy Output (RY/BY)

Hardware method for detection of program or erase cycle completion

## Automatic Sleep Mode

When addresses remain stable, automatically switch themselves to low power mode.

#### Erase Suspend/Resume

Suspends the erase operation to allow a read data and/or program in another sector within the same device.

#### • Sector Group Protection

Hardware method disables any combination of sector groups from program or erase operations.

- Sector Group Protection Set Function by Extended Sector Group Protection Command
- Fast Programming Function by Extended Command
- Temporary Sector Group Unprotection

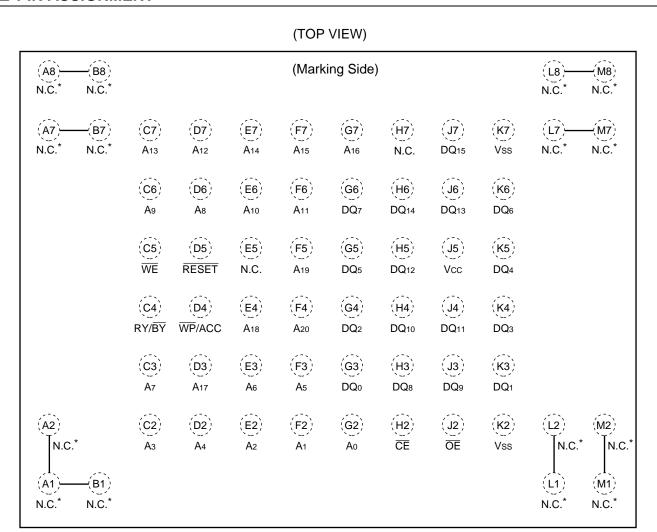
Temporary sector group unprotection via the  $\overline{\mathsf{RESET}}$  pin.

\*: Embedded Erase™ and Embedded Program™ are trademarks of Advanced Micro Devices, Inc.

## MBM29PDS322TE/BE Device Bank Division

Device	Organization		Bank 1		Bank 2
Part Number	Organization	Megabits	Sector Sizes	Megabits	Sector Sizes
MBM29PDS322TE/BE	×16	4 Mbit	Eight 4 K word, seven 32 K word	28 Mbit	Fifty-six 32 K word

# **■ PIN ASSIGNMENT**



(BGA-63P-M01)

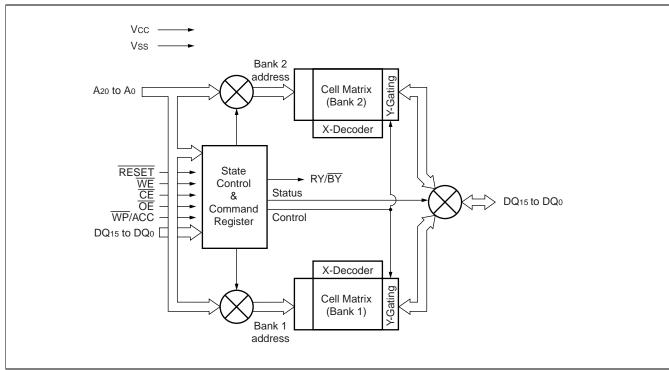
<sup>\*:</sup> Peripheral balls on each corner are shorted together via the substrate but not connected to the die.

# **■ PIN DESCRIPTION**

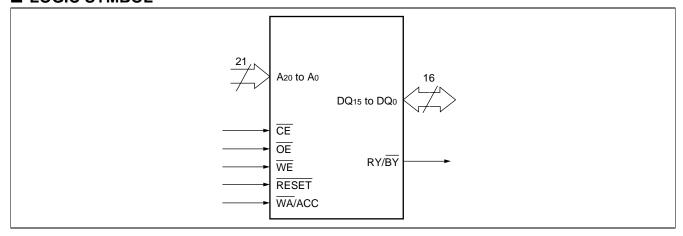
# MBM29PDS322TE/BE Pin Configuration

Pin name	Function
A <sub>20</sub> to A <sub>0</sub>	Address Inputs
DQ <sub>15</sub> to DQ <sub>0</sub>	Data Inputs/Outputs
CE	Chip Enable
ŌĒ	Output Enable
WE	Write Enable
RY/BY	Ready/Busy Output
RESET	Hardware Reset Pin/Temporary Sector Group Unprotection
WP/ACC	Hardware Write Protection/Program Acceleration
N.C.	No Internal Connection
Vss	Device Ground
Vcc	Device Power Supply

# **■ BLOCK DIAGRAM**



# **■ LOGIC SYMBOL**



## **■ DEVICE BUS OPERATION**

## MBM29PDS322TE/BE User Bus Operations Table

Operation	CE	OE	WE	Ao	<b>A</b> 1	<b>A</b> <sub>2</sub>	Аз	<b>A</b> 6	<b>A</b> 9	DQ <sub>15</sub> to DQ <sub>0</sub>	RESET	WP/ ACC
Auto-Select Manufacturer Code *1	L	L	Н	L	L	L	L	L	VID	Code	Н	Х
Auto-Select Device Code *1	L	L	Н	Н	L	L	L	L	VID	Code	Н	Х
Extended Auto-Select Device Code *1	L	L	Н	L/H	Н	Н	Н	L	VID	Code	Н	Х
Read *3	L	L	Н	Ao	A <sub>1</sub>	A <sub>2</sub>	Аз	<b>A</b> 6	<b>A</b> 9	<b>D</b> ouт	Н	Х
Standby	Н	Х	Х	Х	Χ	Х	Χ	Χ	Х	High-Z	Н	Х
Output Disable	L	Н	Н	Х	Χ	Х	Х	Χ	Х	High-Z	Н	Х
Write (Program/Erase)	L	Н	L	A <sub>0</sub>	A <sub>1</sub>	<b>A</b> <sub>2</sub>	Аз	<b>A</b> 6	<b>A</b> 9	Din	Н	Х
Enable Sector Group Protection *2, *4	L	VID		L	Н	L	L	L	VID	Х	Н	Х
Verify Sector Group Protection	L	L	Н	L	Н	L	L	L	VID	Code	Н	Х
Temporary Sector Group Unprotection *5	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	VID	Х
Reset (Hardware) / Standby	Χ	Х	Х	Х	Χ	Х	Χ	Х	Χ	High-Z	L	Х
Boot Block Sector Write Protection *6	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	L

Legend: L = V<sub>I</sub>, H = V<sub>I</sub>, X = V<sub>I</sub> or V<sub>I</sub>, ¬¬¬ = Pulse input. See "■ DC CHARACTERISTICS" for voltage levels.

<sup>\*1:</sup> Manufacturer and device codes may also be accessed via a command register write sequence. See "MBM29PDS322TE/BE User Bus Operations" Table.

<sup>\*2:</sup> Refer to section on Sector Group Protection.

<sup>\*3:</sup>  $\overline{\text{WE}}$  can be  $V_{\text{IL}}$  if  $\overline{\text{OE}}$  is  $V_{\text{IL}}$ ,  $\overline{\text{OE}}$  at  $V_{\text{IH}}$  initiates the write operations.

<sup>\*4:</sup> Vcc must be between the minimum and maximum of the operation range.

<sup>\*5:</sup> Also used for the extended sector group protection.

<sup>\*6:</sup> Protect "outermost" 2 × 4 K words of the boot block sectors.

#### MBM29PDS322TE/BE Command Definitions Table

Commar Sequence		Bus Write Cycles	First Write (		Second Write		Third Write		Fourth Read/ Cyc	<b>Vrite</b>	Fifth Write		Sixth Write	
		Req'd	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data
Read/Reset	Word	1	XXXh	F0h	_	_	_	_	_	_	_	_	_	_
Read/Reset	Word	3	555h	AAh	2AAh	55h	555h	F0h	RA	RD	_	_	_	_
Auto select	Word	3	555h	AAh	2AAh	55h	(BA) 555h	90h	_	_	_	_	_	_
Program	Word	4	555h	AAh	2AAh	55h	555h	A0h	PA	PD	_	_	_	_
Chip Erase	Word	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	555h	10h
Sector Erase	Word	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	SA	30h
Erase Susper	nd	1	ВА	B0h	_	_	_	_	_	_	_	_	_	_
Erase Resum	е	1	ВА	30h	_	_	_	_	_		_	_	_	_
Set to Fast Mode	Word	3	555h	AAh	2AAh	55h	555h	20h	_	_	_	_	_	_
Fast Program *1	Word	2	XXXh	A0h	PA	PD	_	_	_	_	_	_	_	_
Reset from Fast Mode *1	Word	2	ВА	90h	XXXh	*4 F0h	_	_	_	_	_	_	_	_
Extended Sector Group Protection *2	Word	4	XXXh	60h	SPA	60h	SPA	40h	SPA	SD	_	_	_	_
HiddenROM Entry	Word	3	555h	AAh	2AAh	55h	555h	88h	_	_	_	_	_	_
HiddenROM Program *3	Word	4	555h	AAh	2AAh	55h	555h	A0h	(HRA) PA	PD	_	_	_	_
HiddenROM Erase *3	Word	6	555h	AAh	2AAh	55h	555h	80h	555h	AAh	2AAh	55h	HRA	30h
HiddenROM Exit *3	Word	4	555h	AAh	2AAh	55h	(HRBA) 555h	90h	XXXh	00h	_	_	_	_

<sup>\*1:</sup> This command is valid during Fast Mode.

Notes:  $\bullet$  Address bits A<sub>20</sub> to A<sub>12</sub> = X = "H" or "L" for all address commands except or Program Address (PA), Sector Address (SA), and Bank Address (BA).

- Bus operations are defined in "Simultaneous Operation Table" in "■FUNCTIONAL DESCRIPTION".
- RA = Address of the memory location to be read
  - PA = Address of the memory location to be programmed Addresses are latched on the falling edge of the write pulse.
  - SA = Address of the sector to be erased. The combination of  $A_{20}$ ,  $A_{19}$ ,  $A_{18}$ ,  $A_{17}$ ,  $A_{16}$ ,  $A_{15}$ ,  $A_{14}$ ,  $A_{13}$ , and  $A_{12}$  will uniquely select any sector.
  - $BA = Bank Address (A_{20} to A_{15})$

<sup>\*2:</sup> This command is valid while  $\overline{RESET} = V_{ID}$ .

<sup>\*3:</sup> This command is valid during HiddenROM mode.

<sup>\*4:</sup> The data "00h" is also acceptable.

- RD = Data read from location RA during the read operation.
  - PD = Data to be programmed at location PA. Data is latched on the rising edge of write pulse.
- SPA = Sector group address to be protected. Set sector group address (SGA) and (A6, A1, A0) = (0, 1, 0).
  - SD = Sector group protection verify data. Output 01h at protected sector group addresses and output 00h at unprotected sector group addresses.
- HRA = Address of the HiddenROM area
   29PDS322TE (Top Boot Type)Word Mode:1F8000h to 1FFFFh
   29PDS322BE (Bottom Boot Type)Word Mode:000000h to 007FFFh
- HRBA =Bank Address of the HiddenROM area
   29PDS322TE (Top Boot Type):A20 = A19 = A18 = A17 = A16 = A15 = 1
   29PDS322BE (Bottom Boot Type):A20 = A19 = A18 = A17 = A16 = A15 = 0
- The system should generate the following address patterns:
   Word Mode: 555h or 2AAh to addresses A<sub>10</sub> to A<sub>0</sub>
- Both Read/Reset commands are functionally equivalent, resetting the device to the read mode.
- The command combinations not described MBM29PDS322TE/BE command definitions are illegal.

# MBM29PDS322TE Sector Group Protection Verify Autoselect Codes Table

Туре		A20 to A12	<b>A</b> 6	Аз	<b>A</b> 2	<b>A</b> 1	Ao	Code (HEX)
Manufacture's Cod	de	BA*2	VIL	Vıl	Vıl	Vıl	VIL	04h
Device Code	Word	BA*2	VIL	VıL	Vıl	Vıl	ViH	227Eh
Extended Device	Word	BA*2	VIL	ViH	ViH	ViH	VIL	2206h
Code *3	Word	BA*2	VIL	ViH	ViH	ViH	ViH	2201h
Sector Group Prot	ection	Sector Group Addresses	VIL	VIL	VıL	VIH	VıL	01h <sup>*1</sup>

- \*1 : Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.
- \*2 : When V<sub>ID</sub> is applied, both Bank 1 and Bank 2 become Autoselect mode, which leads to the simultaneous operation unable to be executed. Consequently, specifying the bank address is not demanded. However, the bank address needs to be indicated when Autoselect mode is read out at command mode; because then it becomes OK to activate simultaneous operation.
- \*3 : A read cycle at address (BA)01h outputs device code. When 227Eh was output, this indicates that there will require two additional codes, called Extended Device Codes. Therefore, the system may continue reading out these Extended Device Codes at the address of (BA)0Eh, as well as at (BA)0Fh.

## **Expanded Autoselect Code Table**

Туре		Code	<b>DQ</b> <sub>15</sub>	DQ <sub>14</sub>	<b>DQ</b> <sub>13</sub>	<b>DQ</b> <sub>12</sub>	DQ <sub>11</sub>	<b>DQ</b> <sub>10</sub>	DQ <sub>9</sub>	DQ <sub>8</sub>	DQ <sub>7</sub>	DQ <sub>6</sub>	DQ <sub>5</sub>	DQ <sub>4</sub>	DQ <sub>3</sub>	DQ <sub>2</sub>	DQ <sub>1</sub>	DQ <sub>0</sub>
Manufacturer's Code	•	04h	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device Code	(W)	227Eh	0	0	1	0	0	0	1	0	0	1	1	1	1	1	1	0
Extended	(W)	2206h	0	0	1	0	0	0	1	0	0	0	0	0	0	1	1	0
Device Code	(W)	2201h	0	0	1	0	0	0	1	0	0	0	0	0	0	0	0	1
Sector Group Protection		01h	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

(W): Word mode

## MBM29PDS322BE Sector Group Protection Verify Autoselect Codes Table

Туре		A20 to A12	<b>A</b> 6	<b>A</b> 3	<b>A</b> <sub>2</sub>	<b>A</b> 1	Ao	Code (HEX)
Manufacture's Cod	de	BA*2	VIL	Vıl	VIL	Vıl	VIL	04h
Device Code	Word	BA*2	VIL	VIL	VIL	Vıl	VIH	227Eh
Extended Device	Word	BA*2	VIL	ViH	ViH	ViH	VIL	2206h
Code *3	Word	BA*2	VIL	ViH	Vıн	ViH	VIH	2200h
Sector Group Prot	ection	Sector Group Addresses	VIL	VıL	VıL	VIH	VIL	01h <sup>*1</sup>

- \*1 : Outputs 01h at protected sector group addresses and outputs 00h at unprotected sector group addresses.
- \*2 : When V<sub>ID</sub> is applied, both Bank 1 and Bank 2 become Autoselect mode, which leads to the simultaneous operation unable to be executed. Consequently, specifying the bank address is not demanded. However, the bank address needs to be indicated when Autoselect mode is read out at command mode; because then it becomes OK to activate simultaneous operation.
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#### **Expanded Autoselect Code Table**

Туре		Code	<b>DQ</b> <sub>15</sub>	<b>DQ</b> <sub>14</sub>	<b>DQ</b> <sub>13</sub>	<b>DQ</b> <sub>12</sub>	DQ <sub>11</sub>	<b>DQ</b> <sub>10</sub>	DQ <sub>9</sub>	DQ <sub>8</sub>	DQ <sub>7</sub>	$DQ_6$	DQ <sub>5</sub>	DQ <sub>4</sub>	DQ <sub>3</sub>	$DQ_2$	DQ <sub>1</sub>	$\mathbf{DQ}_0$
Manufacturer' Code	S	04h	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device Code	(W)	227Eh	0	0	1	0	0	0	1	0	0	1	1	1	1	1	1	0
Extended	(W)	2206h	0	0	1	0	0	0	1	0	0	0	0	0	0	1	1	0
Device Code	(W)	2200h	0	0	1	0	0	0	1	0	0	0	0	0	0	0	0	0
Sector Group Protection		01h	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

(W): Word mode

# **■ FLEXIBLE SECTOR-ERASE ARCHITECTURE**

Sector Address Table (MBM29PDS322TE)

						or Add		ioic (ii	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	J. DO.	Sector	
Bank	Sector		В	ank A							Sector Size	(×16)
		<b>A</b> 20	<b>A</b> 19	<b>A</b> 18	<b>A</b> 17	<b>A</b> 16	<b>A</b> 15	<b>A</b> 14	<b>A</b> 13	<b>A</b> 12	(Kwords)	Address Range
	SA0	0	0	0	0	0	0	Χ	Χ	Х	32	000000h to 007FFFh
	SA1	0	0	0	0	0	1	Х	Х	Χ	32	008000h to 00FFFFh
	SA2	0	0	0	0	1	0	Х	Х	Χ	32	010000h to 017FFFh
	SA3	0	0	0	0	1	1	Х	Χ	Χ	32	018000h to 01FFFFh
	SA4	0	0	0	1	0	0	Χ	Χ	Χ	32	020000h to 027FFFh
	SA5	0	0	0	1	0	1	Χ	Χ	Χ	32	028000h to 02FFFFh
	SA6	0	0	0	1	1	0	Χ	Χ	Χ	32	030000h to 037FFFh
	SA7	0	0	0	1	1	1	Х	Х	Χ	32	038000h to 03FFFFh
	SA8	0	0	1	0	0	0	Х	Χ	Χ	32	040000h to 047FFFh
	SA9	0	0	1	0	0	1	Х	Χ	Χ	32	048000h to 04FFFFh
	SA10	0	0	1	0	1	0	Х	Χ	Χ	32	050000h to 057FFFh
	SA11	0	0	1	0	1	1	Х	Х	Χ	32	058000h to 05FFFFh
	SA12	0	0	1	1	0	0	Х	Х	Χ	32	060000h to 067FFFh
	SA13	0	0	1	1	0	1	Х	Х	Χ	32	068000h to 06FFFFh
	SA14	0	0	1	1	1	0	Χ	Χ	Χ	32	070000h to 077FFFh
	SA15	0	0	1	1	1	1	Χ	Χ	Χ	32	078000h to 07FFFFh
	SA16	0	1	0	0	0	0	Χ	Χ	Χ	32	080000h to 087FFFh
Bank 2	SA17	0	1	0	0	0	1	Χ	Х	Χ	32	088000h to 08FFFFh
	SA18	0	1	0	0	1	0	Χ	Х	Χ	32	090000h to 097FFFh
	SA19	0	1	0	0	1	1	Х	Х	Χ	32	098000h to 09FFFFh
	SA20	0	1	0	1	0	0	Х	Χ	Χ	32	0A0000h to 0A7FFFh
	SA21	0	1	0	1	0	1	Х	Х	Χ	32	0A8000h to 0AFFFFh
	SA22	0	1	0	1	1	0	Х	Х	Χ	32	0B0000h to 0B7FFFh
	SA23	0	1	0	1	1	1	Х	Х	Χ	32	0B8000h to 0BFFFFh
	SA24	0	1	1	0	0	0	Х	Х	Χ	32	0C0000h to 0C7FFFh
	SA25	0	1	1	0	0	1	Х	Х	Χ	32	0C8000h to 0CFFFFh
	SA26	0	1	1	0	1	0	Х	Х	Χ	32	0D0000h to 0D7FFFh
	SA27	0	1	1	0	1	1	Χ	Х	Χ	32	0D8000h to 0DFFFFh
	SA28	0	1	1	1	0	0	Х	Х	Χ	32	0E0000h to 0E7FFFh
	SA29	0	1	1	1	0	1	Χ	Χ	Χ	32	0E8000h to 0EFFFFh
	SA30	0	1	1	1	1	0	Χ	Χ	Х	32	0F0000h to 0F7FFFh
	SA31	0	1	1	1	1	1	Χ	Χ	Х	32	0F8000h to 0FFFFFh
	SA32	1	0	0	0	0	0	Χ	Χ	Х	32	100000h to 107FFFh
	SA33	1	0	0	0	0	1	Χ	Х	Х	32	108000h to 10FFFFh
	SA34	1	0	0	0	1	0	Χ	Χ	Х	32	110000h to 117FFFh

(Continue	- /				Secto	or Ado	dress				Sector	( 40)
Bank	Sector		В	ank A	ddres	s		<b>A</b> 14	<b>A</b> 13	Λ.,	Size	(×16) Address Range
		<b>A</b> 20	<b>A</b> 19	<b>A</b> 18	<b>A</b> 17	<b>A</b> 16	<b>A</b> 15	A14	A13	<b>A</b> 12	(Kwords)	Addiess Range
	SA35	1	0	0	0	1	1	Х	Χ	Х	32	118000h to 11FFFFh
	SA36	1	0	0	1	0	0	Х	Х	Х	32	120000h to 127FFFh
	SA37	1	0	0	1	0	1	Х	Х	Х	32	128000h to 12FFFFh
	SA38	1	0	0	1	1	0	Х	Χ	Х	32	130000h to 137FFFh
	SA39	1	0	0	1	1	1	Х	Χ	Χ	32	138000h to 13FFFFh
	SA40	1	0	1	0	0	0	Х	Χ	Χ	32	140000h to 147FFFh
	SA41	1	0	1	0	0	1	Х	Х	Х	32	148000h to 14FFFFh
	SA42	1	0	1	0	1	0	Χ	Х	Χ	32	150000h to 157FFFh
	SA43	1	0	1	0	1	1	Χ	Х	Χ	32	158000h to 15FFFFh
	SA44	1	0	1	1	0	0	Х	Х	Х	32	160000h to 167FFFh
Bank 2	SA45	1	0	1	1	0	1	Х	Х	Χ	32	168000h to 16FFFFh
	SA46	1	0	1	1	1	0	Χ	Х	Χ	32	170000h to 177FFFh
	SA47	1	0	1	1	1	1	Х	Х	Х	32	178000h to 17FFFFh
	SA48	1	1	0	0	0	0	Х	Х	Х	32	180000h to 187FFFh
	SA49	1	1	0	0	0	1	Х	Х	Х	32	188000h to 18FFFFh
	SA50	1	1	0	0	1	0	Х	Х	Х	32	190000h to 197FFFh
	SA51	1	1	0	0	1	1	Х	Х	Х	32	198000h to 19FFFFh
	SA52	1	1	0	1	0	0	Х	Х	Х	32	1A0000h to 1A7FFFh
	SA53	1	1	0	1	0	1	Х	Х	Х	32	1A8000h to 1AFFFFh
	SA54	1	1	0	1	1	0	Х	Х	Х	32	1B0000h to 1B7FFFh
	SA55	1	1	0	1	1	1	Х	Х	Χ	32	1B8000h to 1BFFFFh
	SA56	1	1	1	0	0	0	Х	Χ	Χ	32	1C0000h to 1C7FFFh
	SA57	1	1	1	0	0	1	Х	Х	Χ	32	1C8000h to 1CFFFFh
	SA58	1	1	1	0	1	0	Х	Х	Χ	32	1D0000h to 1D7FFFh
	SA59	1	1	1	0	1	1	Х	Х	Х	32	1D8000h to 1DFFFFh
	SA60	1	1	1	1	0	0	Х	Х	Χ	32	1E0000h to 1E7FFFh
	SA61	1	1	1	1	0	1	Х	Х	Χ	32	1E8000h to 1EFFFFh
	SA62	1	1	1	1	1	0	Х	Х	Χ	32	1F0000h to 1F7FFFh
Bank 1	SA63	1	1	1	1	1	1	0	0	0	4	1F8000h to 1F8FFFh
	SA64	1	1	1	1	1	1	0	0	1	4	1F9000h to 1F9FFFh
	SA65	1	1	1	1	1	1	0	1	0	4	1FA000h to 1FAFFFh
	SA66	1	1	1	1	1	1	0	1	1	4	1FB000h to 1FBFFFh
	SA67	1	1	1	1	1	1	1	0	0	4	1FC000h to 1FCFFFh
	SA68	1	1	1	1	1	1	1	0	1	4	1FD000h to 1FDFFFh
	SA69	1	1	1	1	1	1	1	1	0	4	1FE000h to 1FEFFFh
	SA70	1	1	1	1	1	1	1	1	1	4	1FF000h to 1FFFFFh

Sector Address Table (MBM29PDS322BE)

Bank   Sector   Bank Auto   Ans   Ans						Secto	or Add	dress	`			Sector	
SA70	Bank	Sector		В	ank A	ddres	S					Size	
SA69			A <sub>20</sub>	<b>A</b> 19	<b>A</b> 18	<b>A</b> 17	<b>A</b> 16	<b>A</b> 15	<b>A</b> 14	<b>A</b> 13	<b>A</b> 12	(Kwords)	Address Range
SA68		SA70	1	1	1	1	1	1	Χ	Х	Х	32	1F8000h to 1FFFFFh
SA67		SA69	1	1	1	1	1	0	Х	Х	Х	32	1F0000h to 1F7FFFh
SA66		SA68	1	1	1	1	0	1	Х	Х	Х	32	1E8000h to 1EFFFFh
SA65		SA67	1	1	1	1	0	0	Х	Х	Х	32	1E0000h to 1E7FFFh
SA64		SA66	1	1	1	0	1	1	Х	Х	Х	32	1D8000h to 1DFFFFh
SA63		SA65	1	1	1	0	1	0	Х	Х	Х	32	1D0000h to 1D7FFFh
SA62		SA64	1	1	1	0	0	1	Х	Х	Х	32	1C8000h to 1CFFFFh
SA61		SA63	1	1	1	0	0	0	Χ	Х	Χ	32	1C0000h to 1C7FFFh
SA60		SA62	1	1	0	1	1	1	Χ	Х	Χ	32	1B8000h to 1BFFFFh
SA59		SA61	1	1	0	1	1	0	Χ	Х	Χ	32	1B0000h to 1B7FFFh
SA58		SA60	1	1	0	1	0	1	Χ	Х	Χ	32	1A8000h to 1AFFFFh
Bank 2         1         1         0         0         1         0         X         X         32         190000h to 197FFFh           SA56         1         1         0         0         0         1         X         X         32         188000h to 18FFFFh           SA55         1         1         0         0         0         X         X         X         32         180000h to 18FFFFh           SA54         1         0         1         1         1         X         X         X         32         178000h to 17FFFFh           SA53         1         0         1         1         1         0         X         X         X         32         178000h to 17FFFFh           SA52         1         0         1         1         0         X         X         X         32         168000h to 16FFFFh           SA51         1         0         1         1         0         0         X         X         X         32         168000h to 15FFFFh           SA49         1         0         1         0         1         1         X         X         X         32         158000h to 15FFFFh		SA59	1	1	0	1	0	0	Χ	Χ	Χ	32	1A0000h to 1A7FFFh
Bank 2         SA56         1         1         0         0         0         1         X         X         X         32         188000h to 18FFFFh           SA55         1         1         0         0         0         X         X         X         32         180000h to 18FFFFh           SA54         1         0         1         1         1         X         X         X         32         178000h to 17FFFFh           SA53         1         0         1         1         0         X         X         X         32         170000h to 17FFFFh           SA55         1         0         1         1         0         1         X         X         X         32         170000h to 17FFFFh           SA55         1         0         1         1         0         1         X         X         X         32         168000h to 16FFFFh           SA50         1         0         1         0         1         X         X         X         32         158000h to 15FFFFh           SA49         1         0         1         0         0         X         X         X         32         14800		SA58	1	1	0	0	1	1	Χ	Χ	Χ	32	198000h to 19FFFFh
Bank 2    SA55		SA57	1	1	0	0	1	0	Χ	Х	Х	32	190000h to 197FFFh
Bank 2         SA54         1         0         1         1         1         1         X         X         X         32         178000h to 17FFFFh           SA53         1         0         1         1         1         0         X         X         X         32         170000h to 17FFFFh           SA52         1         0         1         1         0         1         X         X         X         32         168000h to 16FFFFh           SA51         1         0         1         1         0         0         X         X         X         32         168000h to 16FFFFh           SA50         1         0         1         0         1         1         X         X         X         32         158000h to 16FFFFh           SA49         1         0         1         0         1         0         X         X         X         32         158000h to 15FFFFh           SA48         1         0         1         0         0         1         X         X         X         32         148000h to 14FFFFh           SA46         1         0         0         1         1         1		SA56	1	1	0	0	0	1	Х	Х	Х	32	188000h to 18FFFFh
Bank 2         SA53         1         0         1         1         1         0         X         X         X         32         170000h to 177FFFh           SA52         1         0         1         1         0         1         X         X         X         32         168000h to 16FFFFh           SA51         1         0         1         1         0         0         X         X         X         32         168000h to 16FFFFh           SA50         1         0         1         0         1         1         X         X         X         32         158000h to 15FFFFh           SA49         1         0         1         0         1         0         X         X         X         32         158000h to 15FFFFh           SA48         1         0         1         0         0         1         X         X         X         32         148000h to 14FFFFh           SA46         1         0         1         1         0         X         X         X         32         138000h to 13FFFFh           SA45         1         0         0         1         0         X         X		SA55	1	1	0	0	0	0	Х	Х	Х	32	180000h to 187FFFh
SA52         1         0         1         1         0         1         X         X         X         32         168000h to 16FFFFh           SA51         1         0         1         1         0         0         X         X         X         32         160000h to 16FFFFh           SA50         1         0         1         0         1         1         X         X         X         32         158000h to 15FFFFh           SA49         1         0         1         0         1         0         X         X         X         32         150000h to 15FFFh           SA48         1         0         1         0         0         1         X         X         X         32         148000h to 15FFFh           SA48         1         0         1         0         0         1         X         X         X         32         148000h to 14FFFFh           SA46         1         0         0         1         1         1         X         X         X         32         138000h to 13FFFFh           SA45         1         0         0         1         0         X         X		SA54	1	0	1	1	1	1	Х	Х	Х	32	178000h to 17FFFFh
SA52         1         0         1         1         0         1         X         X         X         32         168000h to 16FFFh           SA51         1         0         1         1         0         0         X         X         X         32         160000h to 16FFFh           SA50         1         0         1         0         1         1         X         X         X         32         158000h to 15FFFh           SA49         1         0         1         0         X         X         X         32         150000h to 15FFFh           SA48         1         0         1         0         0         1         X         X         32         148000h to 14FFFh           SA47         1         0         1         0         0         X         X         X         32         148000h to 14FFFh           SA46         1         0         0         1         1         X         X         X         32         138000h to 13FFFFh           SA45         1         0         0         1         1         X         X         X         32         128000h to 12FFFFh <td< td=""><td>D. I.O.</td><td>SA53</td><td>1</td><td>0</td><td>1</td><td>1</td><td>1</td><td>0</td><td>Х</td><td>Х</td><td>Х</td><td>32</td><td>170000h to 177FFFh</td></td<>	D. I.O.	SA53	1	0	1	1	1	0	Х	Х	Х	32	170000h to 177FFFh
SA50         1         0         1         1         X         X         X         32         158000h to 15FFFh           SA49         1         0         1         0         1         0         X         X         X         32         150000h to 15FFFh           SA48         1         0         1         0         0         1         X         X         X         32         148000h to 15FFFh           SA47         1         0         1         0         0         0         X         X         X         32         148000h to 14FFFh           SA46         1         0         1         1         1         X         X         X         32         138000h to 13FFFh           SA45         1         0         0         1         1         0         X         X         X         32         138000h to 13FFFh           SA44         1         0         0         1         1         X         X         X         32         128000h to 12FFFFh           SA43         1         0         0         1         1         X         X         X         32         118000h to 12FFFFh	Bank 2	SA52	1	0	1	1	0	1	Х	Х	Х	32	168000h to 16FFFFh
SA49         1         0         1         0         1         0         X         X         X         32         150000h to 157FFFh           SA48         1         0         1         0         0         1         X         X         X         32         148000h to 14FFFFh           SA47         1         0         1         0         0         X         X         X         32         140000h to 147FFFh           SA46         1         0         0         1         1         X         X         X         32         138000h to 13FFFFh           SA45         1         0         0         1         1         0         X         X         X         32         138000h to 13FFFFh           SA44         1         0         0         1         0         X         X         X         32         128000h to 12FFFFh           SA43         1         0         0         1         1         X         X         X         32         128000h to 127FFFh           SA41         1         0         0         0         1         1         X         X         X         32         118000h to		SA51	1	0	1	1	0	0	Х	Х	Х	32	160000h to 167FFFh
SA48         1         0         1         0         0         1         X         X         X         32         148000h to 14FFFFh           SA47         1         0         1         0         0         0         X         X         X         32         140000h to 14FFFFh           SA46         1         0         0         1         1         X         X         X         32         138000h to 13FFFFh           SA45         1         0         0         1         1         0         X         X         X         32         138000h to 13FFFFh           SA44         1         0         0         1         0         1         X         X         X         32         128000h to 12FFFFh           SA43         1         0         0         1         0         0         X         X         X         32         128000h to 12FFFFh           SA42         1         0         0         0         1         1         X         X         X         32         118000h to 117FFFh           SA40         1         0         0         0         1         X         X         X		SA50	1	0	1	0	1	1	Х	Х	Х	32	158000h to 15FFFFh
SA47         1         0         1         0         0         0         X         X         32         140000h to 147FFh           SA46         1         0         0         1         1         X         X         X         32         138000h to 13FFFh           SA45         1         0         0         1         1         0         X         X         X         32         130000h to 13FFFh           SA44         1         0         0         1         0         X         X         X         32         128000h to 12FFFh           SA43         1         0         0         1         0         0         X         X         X         32         128000h to 12FFFh           SA42         1         0         0         0         1         1         X         X         X         32         118000h to 11FFFh           SA41         1         0         0         0         1         0         X         X         X         32         110000h to 11FFFh           SA39         1         0         0         0         0         X         X         X         32         108000h to 10FFFh		SA49	1	0	1	0	1	0	Х	Х	Χ	32	150000h to 157FFFh
SA46       1       0       0       1       1       1       X       X       X       32       138000h to 13FFFh         SA45       1       0       0       1       1       0       X       X       X       32       138000h to 13FFFh         SA44       1       0       0       1       0       1       X       X       X       32       128000h to 12FFFh         SA43       1       0       0       1       0       0       X       X       X       32       128000h to 12FFFh         SA42       1       0       0       0       1       1       X       X       X       32       118000h to 11FFFh         SA41       1       0       0       0       1       0       X       X       X       32       110000h to 117FFFh         SA40       1       0       0       0       0       1       X       X       X       32       108000h to 10FFFFh         SA38       0       1       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA36       0       1       1 <t< td=""><td></td><td>SA48</td><td>1</td><td>0</td><td>1</td><td>0</td><td>0</td><td>1</td><td>Х</td><td>Х</td><td>Х</td><td>32</td><td>148000h to 14FFFFh</td></t<>		SA48	1	0	1	0	0	1	Х	Х	Х	32	148000h to 14FFFFh
SA45       1       0       0       1       1       0       X       X       X       32       130000h to 137FFFh         SA44       1       0       0       1       0       1       X       X       X       32       128000h to 12FFFFh         SA43       1       0       0       1       0       0       X       X       X       32       120000h to 127FFFh         SA42       1       0       0       0       1       1       X       X       X       32       118000h to 11FFFFh         SA41       1       0       0       0       1       0       X       X       X       32       110000h to 117FFFh         SA40       1       0       0       0       0       1       X       X       X       32       108000h to 10FFFFh         SA39       1       0       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFFh         SA36       0       1       1       1       0		SA47	1	0	1	0	0	0	Х	Х	Х	32	140000h to 147FFFh
SA44       1       0       0       1       X       X       X       32       128000h to 12FFFh         SA43       1       0       0       1       0       0       X       X       X       32       120000h to 12FFFh         SA42       1       0       0       0       1       1       X       X       X       32       118000h to 11FFFh         SA41       1       0       0       0       1       0       X       X       X       32       110000h to 117FFFh         SA40       1       0       0       0       1       X       X       X       32       108000h to 10FFFFh         SA39       1       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA36       0       1       1       1       1       X       X       X       32       0E8000h to 0EFFFFh		SA46	1	0	0	1	1	1	Х	Х	Х	32	138000h to 13FFFFh
SA43       1       0       0       1       0       0       X       X       X       32       120000h to 127FFFh         SA42       1       0       0       0       1       1       X       X       X       32       118000h to 11FFFh         SA41       1       0       0       0       1       0       X       X       X       32       110000h to 117FFFh         SA40       1       0       0       0       1       X       X       X       32       108000h to 10FFFFh         SA39       1       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA37       0       1       1       1       0       X       X       X       32       0F8000h to 0F7FFFh         SA36       0       1       1       1       0       1       X       X       X       32       0E8000h to 0EFFFFh		SA45	1	0	0	1	1	0	Х	Х	Χ	32	130000h to 137FFFh
SA42       1       0       0       0       1       1       X       X       X       32       118000h to 11FFFh         SA41       1       0       0       0       1       0       X       X       X       32       110000h to 117FFFh         SA40       1       0       0       0       1       X       X       X       32       108000h to 10FFFFh         SA39       1       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA37       0       1       1       1       0       X       X       X       32       0F0000h to 0F7FFFh         SA36       0       1       1       1       0       1       X       X       X       32       0E8000h to 0EFFFFh		SA44	1	0	0	1	0	1	Х	Х	Х	32	128000h to 12FFFFh
SA41       1       0       0       1       0       X       X       X       32       110000h to 117FFFh         SA40       1       0       0       0       1       X       X       X       32       108000h to 10FFFFh         SA39       1       0       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFFh         SA37       0       1       1       1       0       X       X       X       32       0F0000h to 0F7FFFh         SA36       0       1       1       1       0       1       X       X       X       32       0E8000h to 0EFFFFh		SA43	1	0	0	1	0	0	Х	Х	Х	32	120000h to 127FFFh
SA40       1       0       0       0       1       X       X       X       32       108000h to 10FFFh         SA39       1       0       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA37       0       1       1       1       0       X       X       X       32       0F0000h to 0F7FFFh         SA36       0       1       1       1       0       1       X       X       X       32       0E8000h to 0EFFFFh		SA42	1	0	0	0	1	1	Х	Х	Х	32	118000h to 11FFFFh
SA39       1       0       0       0       0       X       X       X       32       100000h to 107FFFh         SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFFh         SA37       0       1       1       1       0       X       X       X       32       0F0000h to 0F7FFFh         SA36       0       1       1       1       0       1       X       X       X       32       0E8000h to 0EFFFFh		SA41	1	0	0	0	1	0	Х	Х	Х	32	110000h to 117FFFh
SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA37       0       1       1       1       0       X       X       X       32       0F0000h to 0F7FFFh         SA36       0       1       1       1       0       1       X       X       X       32       0E8000h to 0EFFFh		SA40	1	0	0	0	0	1	Х	Х	Х	32	108000h to 10FFFFh
SA38       0       1       1       1       1       X       X       X       32       0F8000h to 0FFFFh         SA37       0       1       1       1       0       X       X       X       32       0F0000h to 0F7FFFh         SA36       0       1       1       0       1       X       X       X       32       0E8000h to 0EFFFh		SA39	1	0	0	0	0	0	Х	Х	Х	32	100000h to 107FFFh
SA36 0 1 1 1 0 1 X X X 32 0E8000h to 0EFFFFh		SA38	0	1	1	1	1	1	Х	Х	Х	32	0F8000h to 0FFFFFh
		SA37	0	1	1	1	1	0	Х	Х	Х	32	0F0000h to 0F7FFFh
SA35 0 1 1 1 0 0 X X X 32 0E0000h to 0E7FFFh		SA36	0	1	1	1	0	1	Х	Х	Х	32	0E8000h to 0EFFFFh
		SA35	0	1	1	1	0	0	Х	Х	Х	32	0E0000h to 0E7FFFh

		Sector Address								Sector	(40)	
Bank	Sector	Bank Address					<b>A</b> 14	<b>A</b> 13	<b>A</b> 12	Size	(x16) Address Range	
		<b>A</b> 20	<b>A</b> 19	<b>A</b> 18	<b>A</b> 17	<b>A</b> 16	<b>A</b> 15	<b>A</b> 14			(Kwords)	Addicos Range
	SA34	0	1	1	0	1	1	Х	Χ	Х	32	0D8000h to 0DFFFFh
	SA33	0	1	1	0	1	0	Х	Χ	Х	32	0D0000h to 0D7FFFh
	SA32	0	1	1	0	0	1	Х	Χ	Χ	32	0C8000h to 0CFFFFh
	SA31	0	1	1	0	0	0	Х	Χ	Χ	32	0C0000h to 0C7FFFh
	SA30	0	1	0	1	1	1	Х	Χ	Χ	32	0B8000h to 0BFFFFh
	SA29	0	1	0	1	1	0	Х	Χ	Χ	32	0B0000h to 0B7FFFh
	SA28	0	1	0	1	0	1	Х	Χ	Χ	32	0A8000h to 0AFFFFh
	SA27	0	1	0	1	0	0	Х	Χ	Χ	32	0A0000h to 0A7FFFh
	SA26	0	1	0	0	1	1	Х	Χ	Х	32	098000h to 09FFFFh
Bank 2	SA25	0	1	0	0	1	0	Х	Χ	Χ	32	090000h to 097FFFh
Dalik Z	SA24	0	1	0	0	0	1	Х	Χ	Х	32	088000h to 08FFFFh
	SA23	0	1	0	0	0	0	Х	Χ	Χ	32	080000h to 087FFFh
	SA22	0	0	1	1	1	1	Х	Χ	Χ	32	078000h to 07FFFFh
	SA21	0	0	1	1	1	0	Х	Χ	Χ	32	070000h to 077FFFh
	SA20	0	0	1	1	0	1	Х	Χ	Χ	32	068000h to 06FFFFh
	SA19	0	0	1	1	0	0	Х	Χ	Х	32	060000h to 067FFFh
	SA18	0	0	1	0	1	1	Х	Χ	Х	32	058000h to 05FFFFh
	SA17	0	0	1	0	1	0	Х	Χ	Х	32	050000h to 057FFFh
	SA16	0	0	1	0	0	1	Х	Χ	Χ	32	048000h to 04FFFFh
	SA15	0	0	1	0	0	0	Х	Χ	Х	32	040000h to 047FFFh
	SA14	0	0	0	1	1	1	Х	Χ	Х	32	038000h to 03FFFFh
	SA13	0	0	0	1	1	0	Х	Χ	Х	32	030000h to 037FFFh
	SA12	0	0	0	1	0	1	Х	Χ	Χ	32	028000h to 02FFFFh
	SA11	0	0	0	1	0	0	Х	Χ	Χ	32	020000h to 027FFFh
	SA10	0	0	0	0	1	1	Х	Χ	Χ	32	018000h to 01FFFFh
	SA9	0	0	0	0	1	0	Х	Χ	Χ	32	010000h to 017FFFh
	SA8	0	0	0	0	0	1	Х	Χ	Χ	32	008000h to 00FFFFh
Bank 1	SA7	0	0	0	0	0	0	1	1	1	4	007000h to 007FFFh
	SA6	0	0	0	0	0	0	1	1	0	4	006000h to 006FFFh
	SA5	0	0	0	0	0	0	1	0	1	4	005000h to 005FFFh
	SA4	0	0	0	0	0	0	1	0	0	4	004000h to 004FFFh
	SA3	0	0	0	0	0	0	0	1	1	4	003000h to 003FFFh
	SA2	0	0	0	0	0	0	0	1	0	4	002000h to 002FFFh
	SA1	0	0	0	0	0	0	0	0	1	4	001000h to 001FFFh
	SA0	0	0	0	0	0	0	0	0	0	4	000000h to 000FFFh

Sector Group Address Table (MBM29PDS322TE) (Top Boot Block)

Sector Group	<b>A</b> 20	<b>A</b> 19	<b>A</b> 18	<b>A</b> 17	<b>A</b> 16	<b>A</b> 15	<b>A</b> 14	<b>A</b> 13	<b>A</b> 12	Sectors	
SGA0	0	0	0	0	0	0	Х	Х	Χ	SA0	
					0	1					
SGA1	0	0	0	0	1	0	Х	X	Χ	SA1 to SA3	
					1	1					
SGA2	0	0	0	1	Х	Х	Х	Х	Х	SA4 to SA7	
SGA3	0	0	1	0	Х	Х	Х	Х	Х	SA8 to SA11	
SGA4	0	0	1	1	Х	Х	Х	Х	Х	SA12 to SA15	
SGA5	0	1	0	0	Х	Х	Х	Х	Х	SA16 to SA19	
SGA6	0	1	0	1	Х	Х	Х	Х	Х	SA20 to SA23	
SGA7	0	1	1	0	Х	Х	Х	Х	Х	SA24 to SA27	
SGA8	0	1	1	1	Х	Х	Х	Х	Х	SA28 to SA31	
SGA9	1	0	0	0	Х	Х	Х	Х	Х	SA32 to SA35	
SGA10	1	0	0	1	Х	Х	Х	Х	Х	SA36 to SA39	
SGA11	1	0	1	0	Х	Х	Х	Х	Х	SA40 to SA43	
SGA12	1	0	1	1	Х	Х	Х	Х	Х	SA44 to SA47	
SGA13	1	1	0	0	X	Х	Х	Х	Χ	SA48 to SA51	
SGA14	1	1	0	1	Х	Х	Х	Х	Х	SA52 to SA55	
SGA15	1	1	1	0	Х	Х	Х	Х	Х	SA56 to SA59	
					0	0					
SGA16	1	1	1	1	0	1	Х	X	Χ	SA60 to SA62	
					1	0					
SGA17	1	1	1	1	1	1	0	0	0	SA63	
SGA18	1	1	1	1	1	1	0	0	1	SA64	
SGA19	1	1	1	1	1	1	0	1	0	SA65	
SGA20	1	1	1	1	1	1	0	1	1	SA66	
SGA21	1	1	1	1	1	1	1	0	0	SA67	
SGA22	1	1	1	1	1	1	1	0	1	SA68	
SGA23	1	1	1	1	1	1	1	1	0	SA69	
SGA24	1	1	1	1	1	1	1	1	1	SA70	

Sector Group Address Table (MBM29PDS322BE) (Bottom Boot Block)

Sector Group	<b>A</b> 20	<b>A</b> 19	<b>A</b> 18	<b>A</b> 17	<b>A</b> 16	<b>A</b> 15	<b>A</b> 14	<b>A</b> 13	<b>A</b> 12	Sectors
SGA0	0	0	0	0	0	0	0	0	0	SA0
SGA1	0	0	0	0	0	0	0	0	1	SA1
SGA2	0	0	0	0	0	0	0	1	0	SA2
SGA3	0	0	0	0	0	0	0	1	1	SA3
SGA4	0	0	0	0	0	0	1	0	0	SA4
SGA5	0	0	0	0	0	0	1	0	1	SA5
SGA6	0	0	0	0	0	0	1	1	0	SA6
SGA7	0	0	0	0	0	0	1	1	1	SA7
					0	1				
SGA8	0	0	0	0	1	0	Х	X	X	SA8 to SA10
					1	1				
SGA9	0	0	0	1	Χ	Х	Х	Х	Х	SA11 to SA14
SGA10	0	0	1	0	Χ	Х	Х	Х	Х	SA15 to SA18
SGA11	0	0	1	1	Χ	Х	Х	Х	Х	SA19 to SA22
SGA12	0	1	0	0	Х	Х	Х	Х	Х	SA23 to SA26
SGA13	0	1	0	1	Х	Х	Х	Х	Х	SA27 to SA30
SGA14	0	1	1	0	Х	Х	Х	Х	Х	SA31 to SA34
SGA15	0	1	1	1	Х	Х	Х	Х	Х	SA35 to SA38
SGA16	1	0	0	0	Х	Х	Х	Х	Х	SA39 to SA42
SGA17	1	0	0	1	Х	Х	Х	Х	Х	SA43 to SA46
SGA18	1	0	1	0	Х	Х	Х	Х	Х	SA47 to SA50
SGA19	1	0	1	1	Х	Х	Х	Х	Х	SA51 to SA54
SGA20	1	1	0	0	Х	Х	Х	Х	Х	SA55 to SA58
SGA21	1	1	0	1	Χ	Х	Х	Х	Х	SA59 to SA62
SGA22	1	1	1	0	X	Х	Х	Х	Х	SA63 to SA66
					0	0				
SGA23	1	1	1	1	0	1	Х	X	Х	SA67 to SA69
					1	0	1			
SGA24	1	1	1	1	1	1	Х	Х	Х	SA70

#### **■ FUNCTIONAL DESCRIPTION**

#### **Simultaneous Operation**

The device has a feature taht is capable of reading data from one bank of memory while a program or erase operation is in progress in the other bank of memory (simultaneous operation), in addition to the conventional features (read, program, erase, erase-suspend read, and erase-suspend program). The bank selection can be selected by bank address (A20 to A15) with zero latency.

The device has two banks which contain

Bank 1 (4 KW × eight sectors, 32 KW × seven sectors) and Bank 2 (32 KW × fifty-six sectors).

The simultaneous operation cannot execute multi-function mode in the same bank. "Simultaneous Operation" Table shows the possible combinations for simultaneous operation. (Refer to "Bank-to-Bank Read/Write Timing Diagram" in "■TIMING DIAGRAM".)

## **Simultaneous Operation Table**

Case	Bank 1 Status	Bank 2 Status							
1	Read mode	Read mode							
2	Read mode	Autoselect mode							
3	Read mode	Program mode							
4	Read mode	Erase mode *							
5	Autoselect mode	Read mode							
6	Program mode	Read mode							
7	Erase mode *	Read mode							

<sup>\*:</sup> Erase operation may also be suspended to read from or program to a sector not being erased.

## **Read Mode**

The device has two control functions to be satisfied for obtaining data at the outputs.  $\overline{CE}$  is the power control and should be used for a device selection.  $\overline{OE}$  is the output control and should be used as the gate data to the output pins if a device is selected.

Address access time (tacc) is equal to the delay from stable addresses to valid output data. The chip enable access time (tce) is the delay from stable addresses and stable  $\overline{CE}$  to valid data at the output pins. The output enable access time (toe) is the delay from the falling edge of  $\overline{OE}$  to valid data at the output pins (assuming the addresses have been stable for at least tacc-toe time). When reading out data without changing addresses after power-up, it is necessary to input hardware reset or to change  $\overline{CE}$  pin from "H" or "L".

# Page Mode Read

The device is capable of fast Page mode read operation. This mode provides faster read access speed for random locations within a page. The Page size of the device is 4 words, within the appropriate Page being selected by the higher address bits  $A_{20}$  to  $A_{2}$  and the LSB bits  $A_{1}$  and  $A_{0}$  within that page. This is an asynchronous operation with the microprocessor supplying the specific word location.

The random or initial page access is equal to tacc and subsequent Page read access (as long as the locations specified by the microprocessor fall within that Page) is equivalent to  $t_{PACC}$ . Here again,  $\overline{CE}$  selects the device and  $\overline{OE}$  is the output control and should be used to gate data to the output pins if the device is selected. Fast Page mode accesses are obtained by keeping  $A_{20}$  to  $A_2$  constant and changing  $A_1$  and  $A_0$  to select the specific word, within that page.

### **Standby Mode**

There are two ways to implement the standby mode on the device, one using both the  $\overline{\text{CE}}$  and  $\overline{\text{RESET}}$  pins; the other via the  $\overline{\text{RESET}}$  pin only.

When using both pins, a CMOS standby mode is achieved with  $\overline{\text{CE}}$  and  $\overline{\text{RESET}}$  inputs both held at  $V\text{cc} \pm 0.3 \text{ V}$ . Under this condition, the current consumed is less than 5  $\mu\text{A}$  Max During Embedded Algorithm operation, Vcc active current (Icc2) is required even  $\overline{\text{CE}}$  = "H". The device can be read with standard access time (IccE) from either of these standby modes.

When using the  $\overline{\text{RESET}}$  pin only, a CMOS standby mode is achieved with  $\overline{\text{RESET}}$  input held at Vss  $\pm$  0.3 V ( $\overline{\text{CE}}$  = "H" or "L"). Under this condition the current consumed is less than 5  $\mu$ A Max Once the  $\overline{\text{RESET}}$  pin is taken high, the device requires treather as wake up time for outputs to be valid for read access.

In the standby mode, the outputs are in the high impedance state, independently of the  $\overline{\text{OE}}$  input.

## **Automatic Sleep Mode**

There is a function called automatic sleep mode to restrain power consumption during read-out of the device data. This mode can be useful in the application such as a handy terminal which requires low power consumption.

To activate this mode, the device automatically switches themselves to low power mode when the device addresses remain stable during access time of 150 ns. It is not necessary to control  $\overline{CE}$ ,  $\overline{WE}$ , and  $\overline{OE}$  on the mode. Under the mode, the current consumed is typically 50  $\mu$ A (CMOS Level).

During simultaneous operation, Vcc active current (Icc2) is required.

Since the data are latched during this mode, the data are read-out continuously. If the addresses are changed, the mode is canceled automatically, and the device reads the data for changed addresses.

## **Output Disable**

With the  $\overline{OE}$  input at a logic high level (V<sub>H</sub>), output from the device is disabled. This will cause the output pins to be in a high impedance state.

## **Autoselect**

The autoselect mode allows the reading out of a binary code from the device and will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional over the entire temperature range of the device.

To activate this mode, the programming equipment must force V<sub>ID</sub> (10.0 V to 11.0 V) on address pin A<sub>9</sub>. Two identifier bytes may then be sequenced from the device outputs by toggling address A<sub>0</sub> from V<sub>IL</sub> to V<sub>IH</sub>. All addresses are DON'T CARES except A<sub>6</sub>, A<sub>3</sub>, A<sub>2</sub>, A<sub>1</sub>, and A<sub>0</sub>. (See "MBM29PDS322TE/BE User Bus Operations" Table in "■DEVICE BUS OPERATION".)

The manufacturer and device codes may also be read via the command register, for instances when the device is erased or programmed in a system without access to high voltage on the A<sub>9</sub> pin. The command sequence is illustrated in "MBM29PDS322TE/BE Command Definitions" Table in "■DEVICE BUS OPERATION". (Refer to Autoselect Command section.)

In the command Autoselect mode, the bank addresses BA;  $(A_{20} \text{ to } A_{12})$  must point to a specific bank during the third write bus cycle of the Autoselect command. Then the Autoselect data will be read from that bank while array data can be read from the other bank.

A read cycle from address (BA)00h returns the manufacturer's code (Fujitsu = 04h). And a read cycle from address (BA)01h, (BA)0Eh to (BA)0Fh returns the device code. (See MBM29PDS322TE's/BE's "Sector Group Protection Verify Autoselect Codes" Tables and "Expanded Autoselect Code" Tables in "DEVICE BUS OPERATION".)

In case of applying V<sub>ID</sub> on A<sub>9</sub>, since both Bank 1 and Bank 2 enter Autoselect mode, the simultaneous operation can not be executed.

#### Write

Device erasure and programming are accomplished via the command register. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device.

The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The command register is written by bringing  $\overline{WE}$  to  $V_{IL}$ , while  $\overline{CE}$  is at  $V_{IL}$  and  $\overline{OE}$  is at  $V_{IH}$ . Addresses are latched on the falling edge of  $\overline{WE}$  or  $\overline{CE}$ , whichever happens later; while data is latched on the rising edge of  $\overline{WE}$  or  $\overline{CE}$ , whichever happens first. Standard microprocessor write timings are used.

Refer to AC Write Characteristics and the Erase/Programming Waveforms for specific timing parameters.

## **Sector Group Protection**

The device features hardware sector group protection. This feature will disable both program and erase operations in any combination of twenty five sector groups of memory. (See MBM29PDS322TE's/BE's "Sector Group Address" Tables in "■FLEXIBLE SECTOR-ERASE ARCHITECTURE".) The sector group protection feature is enabled using programming equipment at the user's site. The device is shipped with all sector groups unprotected.

To activate this mode, the programming equipment must force V<sub>ID</sub> on address pin A<sub>9</sub> and control pin  $\overline{OE}$ , (suggest V<sub>ID</sub> = 11.5 V),  $\overline{CE}$  = V<sub>IL</sub> and (A<sub>6</sub>, A<sub>3</sub>, A<sub>2</sub>, A<sub>1</sub>, A<sub>0</sub>) = (0, 0, 0, 1, 0). The sector group addresses (A<sub>20</sub>, A<sub>19</sub>, A<sub>18</sub>, A<sub>17</sub>, A<sub>16</sub>, A<sub>15</sub>, A<sub>14</sub>, A<sub>13</sub>, and A<sub>12</sub>) should be set to the sector to be protected. "Sector Address" Tables (MBM29PDS322TE and MBM29PDS322BE) in "■FLEXIBLE SECTOR-ERASE ARCHITECTURE" define the sector address for each of the seventy one (71) individual sectors, and "Sector Group Address" Tables (MBM29PDS322TE and MBM29PDS322BE) in "■FLEXIBLE SECTOR-ERASE ARCHITECTURE" define the sector group address for each of the twenty five (25) individual group sectors. Programming of the protection circuitry begins on the falling edge of the WE pulse and is terminated with the rising edge of the same. Sector group addresses must be held constant during the WE pulse. See "Sector Group Protection Timing Diagram" in "■TIMING DIAGRAM" and "Sector Group Protection Algorithm" in "■FLOW CHARTS" for sector group protection waveforms and algorithm.

To verify programming of the protection circuitry, the programming equipment must force  $V_{ID}$  on address pin  $A_9$  with  $\overline{CE}$  and  $\overline{OE}$  at  $V_{IL}$  and  $\overline{WE}$  at  $V_{IH}$ . Scanning the sector group addresses ( $A_{20}$ ,  $A_{19}$ ,  $A_{18}$ ,  $A_{17}$ ,  $A_{16}$ ,  $A_{15}$ ,  $A_{14}$ ,  $A_{13}$ , and  $A_{12}$ ) while ( $A_6$ ,  $A_3$ ,  $A_2$ ,  $A_1$ ,  $A_0$ ) = (0, 0, 0, 1, 0) will produce a logical "1" code at device output DQ<sub>0</sub> for a protected sector. Otherwise the device will produce "0" for unprotected sector. In this mode, the lower order addresses, except for  $A_0$ ,  $A_1$ ,  $A_2$ ,  $A_3$ , and  $A_6$  are DON'T CARES. Address locations with  $A_1 = V_{IL}$  are reserved for Autoselect manufacturer and device codes.

#### **Temporary Sector Group Unprotection**

This feature allows temporary unprotection of previously protected sector groups of the device in order to change data. The Sector Group Unprotection mode is activated by setting the RESET pin to high voltage (V<sub>ID</sub>). During this mode, formerly protected sector groups can be programmed or erased by selecting the sector group addresses. Once the V<sub>ID</sub> is taken away from the RESET pin, all the previously protected sector groups will be protected again. Refer to "Temporary Sector Group Unprotection Timing Diagram" in "■TIMING DIAGRAM" and "Temporary Sector Group Unprotection Algorithm" in "■FLOW CHARTS".

## **Extended Sector Group Protection**

#### **RESET**

Hardware Reset

The device may be reset by driving the RESET pin to V<sub>IL</sub>. The RESET pin vs. a pulse requirement and has to be kept low (V<sub>IL</sub>) for at least "t<sub>RP</sub>" in order to properly reset the internal state machine. Any operation in the process of being executed will be terminated and the internal state machine will be reset to the read mode "t<sub>READY</sub>" after the RESET pin is driven low. Furthermore, once the RESET pin goes high, the device requires an additional "t<sub>RH</sub>" before it will allow read access. When the RESET pin is low, the device will be in the standby mode for the duration of the pulse and all the data output pins will be tri-stated. If a hardware reset occurs during a program or erase operation, the data at that particular location will be corrupted. Please note that the RY/BY output signal should be ignored during the RESET pulse. See "RESET, RY/BY Timing Diagram" in "TIMING DIAGRAM" for the timing diagram. Refer to Temporary Sector Group Unprotection for additional functionality.

#### **Boot Block Sector Protection**

The Write Protection function provides a hardware method of protecting certain boot sectors without using  $V_{ID}$ . This function is one of two provided by the  $\overline{WP}/ACC$  pin.

If the system asserts  $V_{IL}$  on the  $\overline{WP}/ACC$  pin, the device disables program and erase functions in the two "outermost" 4K word boot sectors independently of whether those sectors are protected or unprotected using the method described in "Sector Protection/Unprotection". The two outermost 4K word boot sectors are the two sectors containing the lowest addresses in a bottom-boot-configured device, or the two sectors containing the highest addresses in a top-boot-congfigured device.

(MBM29PDS322TE: SA69 and SA70, MBM29PDS322BE: SA0 and SA1)

If the system asserts  $V_{\text{IH}}$  on the  $\overline{\text{WP}}/\text{ACC}$  pin, the device reverts to whether the two outermost 4K word boot sectors were last set to be protected or unprotected. That is, sector protection or unprotection for these two sectors depends on whether they were last protected or unprotected using the method described in "Sector protection/unprotection".

#### **Accelerated Program Operation**

The device offers accelerated program operation which enables the programming in high speed. If the system asserts  $V_{ACC}$  to the  $\overline{WP}/ACC$  pin, the device automatically enters the acceleration mode and the time required for program operation will reduce to about 60%. This function is primarily intended to allow high speed program, so caution is needed as the sector group will temporarily be unprotected.

The system would use a fast program command sequence when programming during acceleration mode. Set command to fast mode and reset command from fast mode are not necessary. When the device enters the

acceleration mode, the device automatically set to fast mode. Therefore, the present sequence could be used for programming and detection of completion during acceleration mode.

Removing Vacc from the WP/ACC pin returns the device to normal operation. Do not remove Vacc from WP/ACC pin while programming. See "Accelerated Program Timing Diagram" in "■TIMING DIAGRAM". Erase operation during Accalerated Program Operation is strictly prohibited.

## **■ COMMAND DEFINITIONS**

The device operations are selected by writing specific address and data sequences into the command register. Some commands require Bank Address (BA) input. When command sequences are inputted to bank being read, the commands have priority over reading. "MBM29PDS322TE/BE Command Definitions" Table in "■DEVICE BUS OPERATION" defines the valid register command sequences. Note that the Erase Suspend (B0h) and Erase Resume (30h) commands are valid only while the Sector Erase operation is in progress. Moreover, both Read/Reset commands are functionally equivalent, resetting the device to the read mode. Please note that commands are always written at DQ7 to DQ₀ and DQ₁₅ to DQ₀ bits are ignored.

#### Read/Reset Command

In order to return from Autoselect mode or Exceeded Timing Limits ( $DQ_5 = 1$ ) to Read/Reset mode, the Read/Reset operation is initiated by writing the Read/Reset command sequence into the command register. Microprocessor read cycles retrieve array data from the memory. The device remains enabled for reads until the command register contents are altered.

The device will automatically power-up in the Read/Reset state. In this case, a command sequence is not required to read data. Standard microprocessor read cycles will retrieve array data. This default value ensures that no spurious alteration of the memory content occurs during the power transition. Refer to the AC Read Characteristics and Waveforms for the specific timing parameters.

#### **Autoselect Command**

Flash memories are intended for use in applications where the local CPU alters memory contents. As such, manufacture and device codes must be accessible while the device resides in the target system. PROM programmers typically access the signature codes by raising  $A_{\theta}$  to a high voltage. However, multiplexing high voltage onto the address lines is not generally desired system design practice.

The device contains an Autoselect command operation to supplement traditional PROM programming methodology. The operation is initiated by writing the Autoselect command sequence into the command register.

The Autoselect command sequence is initiated by firstly writing two unlock cycles. This is followed by a third write cycle that contains the bank address (BA) and the Autoselect command. Then the manufacture and device codes can be read from the bank, and actual data of memory cell can be read from the another bank.

Following the command write, a read cycle from address (BA)00h retrieves the manufacture code of 04h. A read cycle at address (BA)01h returns 7Eh to indicate that this device uses extended device code. The successive read cycle from (BA)0Eh to (BA)0Fh returns this extended device code for this device. (See MBM29PDS322TE's/BE's "Sector Group Protection Verify Autoselect Codes" Tables and "Expanded Autoselect Code" Tables in "EDEVICE BUS OPERATION".)

The manufacture and device codes can be allowed to read from selected bank. To read the manufacture and device codes and sector protection status from non-selected bank, it is necessary to write Read/Reset command sequence into the register and then Autoselect command should be written into the bank to be read.

If the software (program code) for Autoselect command is stored into the Flash memory, the device and manufacture codes should be read from the other bank which doesn't contain the software.

To terminate the operation, it is necessary to write the Read/Reset command sequence into the register. To execute the Autoselect command during the operation, writing Read/Reset command sequence must precede the Autoselect command.

### **Word Programming**

The device is programmed on a word-by-word basis. Programming is a four bus cycle operation. There are two "unlock" write cycles. These are followed by the program set-up command and data write cycles. Addresses are latched on the falling edge of  $\overline{CE}$  or  $\overline{WE}$ , whichever happens later and the data is latched on the rising edge of  $\overline{CE}$  or  $\overline{WE}$ , whichever happens first. The rising edge of  $\overline{CE}$  or  $\overline{WE}$  (whichever happens first) begins programming. Upon executing the Embedded Program Algorithm command sequence, the system is not required to provide further controls or timings. The device automatically provides adequate internally generated program pulses and verify programmed cell margin.

The system can determine the status of the program operation by using  $DQ_7$  ( $\overline{Data}$  Polling),  $DQ_6$  (Toggle Bit), or RY/ $\overline{BY}$ . The  $\overline{Data}$  Polling and Toggle Bit must be performed at the memory location being programmed.

The automatic programming operation is completed when the data on  $DQ_7$  is equivalent to data written to this bit at which the device returns to the read mode and addresses are no longer latched. (See "Hardware Sequence Flags" Table.) Therefore the device requires that a valid address to the device be supplied by the system at this particular moment. Hence  $\overline{D}$  at Polling must be performed at the memory location which is being programmed.

If hardware reset occurs during the programming operation, it is impossible to guarantee the data being written.

Programming is allowed in any sequence and across sector boundaries. Beware that a data "0" cannot be programmed back to a "1". Attempting to do so may either hang up the device or result in an apparent success according to the data polling algorithm but a read from Read/Reset mode will show that the data is still "0". Only erase operations can convert "0"s to "1"s.

"Embedded Program™ Algorithm" in "■FLOW CHARTS" illustrates the Embedded Program™ Algorithm using typical command strings and bus operations.

## **Chip Erase**

Chip erase is a six bus cycle operation. There are two "unlock" write cycles. These are followed by writing the "set-up" command. Two more "unlock" write cycles are then followed by the chip erase command.

Chip erase does not require the user to program the device prior to erase. Upon executing the Embedded Erase Algorithm command sequence the device will automatically program and verify the entire memory for an all zero data pattern prior to electrical erase (Preprogram function). The system is not required to provide any controls or timings during these operations.

The system can determine the status of the erase operation by using  $DQ_7$  ( $\overline{Data}$  Polling),  $DQ_6$  (Toggle Bit), or RY/ $\overline{BY}$ . The chip erase begins on the rising edge of the last  $\overline{CE}$  or  $\overline{WE}$ , whichever happens first in the command sequence and terminates when the data on  $DQ_7$  is "1" (See Write Operation Status section.) at which the device returns to read the mode.

Chip Erase Time: Sector Erase Time × All sectors + Chip Program Time (Preprogramming)

"Embedded Erase™ Algorithm" in "■FLOW CHARTS" illustrates the Embedded Erase™ Algorithm using typical command strings and bus operations.

#### **Sector Erase**

Sector erase is a six bus cycle operation. There are two "unlock" write cycles. These are followed by writing the "set-up" command. Two more "unlock" write cycles are then followed by the Sector Erase command. The sector address (any address location within the desired sector) is latched on the falling edge of  $\overline{CE}$  or  $\overline{WE}$  whichever happens later, while the command (Data = 30h) is latched on the rising edge of  $\overline{CE}$  or  $\overline{WE}$  which happens first. After time-out of "trow" from the rising edge of the last sector erase command, the sector erase operation begins.

Multiple sectors are erased concurrently by writing the six bus cycle operations on "MBM29PDS322TE/BE Command Definitions" Table in "IDEVICE BUS OPERATION". This sequence is followed with writes of the Sector Erase command to addresses in other sectors desired to be concurrently erased. The time between writes must be less than "trow" otherwise that command will not be accepted and erasure does not start. It is recommended that processor interrupts be disabled during this time to guarantee this condition. The interrupts can be re-enabled after the last Sector Erase command is written. A time-out of "trow" from the rising edge of last  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$  whichever happens first will initiate the execution of the Sector Erase command(s). If another falling edge of  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$ , whichever happens first occurs within the "trow" time-out window the timer is reset. (Monitor DQ3 to determine if the sector erase timer window is still open, see section DQ3, Sector Erase Timer.) Resetting the device once execution has begun will corrupt the data in the sector. In that case, restart the erase on those sectors and allow them to complete. (Refer to the Write Operation Status section for Sector Erase Timer operation.) Loading the sector erase buffer may be done in any sequence and with any number of sectors (0 to 70).

Sector erase does not require the user to program the device prior to erase. The device automatically programs all memory locations in the sector(s) to be erased prior to electrical erase (Preprogram function). When erasing a sector or sectors the remaining unselected sectors are not affected. The system is not required to provide any controls or timings during these operations.

The system can determine the status of the erase operation by using  $DQ_7$  ( $\overline{Data}$  Polling),  $DQ_6$  (Toggle Bit), or RY/ $\overline{BY}$ .

The sector erase begins after the "trow" time out from the rising edge of  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$  whichever happens first for the last sector erase command pulse and terminates when the data on DQ7 is "1" (See Write Operation Status section.) at which time the device returns to the read mode.  $\overline{\text{Data}}$  polling and Toggle Bit must be performed at an address within any of the sectors being erased.

Multiple Sector Erase Time : [Sector Erase Time + Sector Program Time (Preprogramming)] × Number of Sector Erase

In case of multiple sector erase across bank boundaries, a read from bank (read-while-erase) can not perform.

"Embedded Erase™ Algorithm" in "■FLOW CHARTS" illustrates the Embedded Erase™ Algorithm using typical command strings and bus operations.

### **Erase Suspend/Resume**

The Erase Suspend command allows the user to interrupt Sector Erase operation and then perform data reads from or programs to a sector not being erased. This command is applicable ONLY during the Sector Erase operation which includes the time-out period for sector erase. Writing the Erase Suspend command (B0h) during the Sector Erase time-out results in immediate termination of the time-out period and suspension of the erase operation.

Writing the Erase Resume command (30h) resumes the erase operation. The bank addresses of sector being erased or erase-suspended should be set when writing the Erase Suspend or Erase Resume command.

When the Erase Suspend command is written during the Sector Erase operation, the device takes a maximum of " $t_{SPD}$ " to suspend the erase operation. When the device has entered the erase-suspended mode, the  $RY/\overline{BY}$  output pin is at Hi-Z and the  $DQ_7$  bit is at logic "1", and  $DQ_6$  stops toggling. The user must use the address of the erasing sector for reading  $DQ_6$  and  $DQ_7$  to determine if the erase operation is suspended. Further writes of the Erase Suspend command are ignored.

When the erase operation has been suspended, the device defaults to the erase-suspend-read mode. Reading data in this mode is the same as reading from the standard read mode except that the data must be read from sectors that have not been erase-suspended. Successively reading from the erase-suspended sector while the device is in the erase-suspend-read mode will cause DQ<sub>2</sub> to toggle. (See the section on DQ<sub>2</sub>.)

After entering the erase-suspend-read mode, the user can program the device by writing the appropriate command sequence for Program. This program mode is known as the erase-suspend-program mode. Again, programming in this mode is the same as programming in the regular Program mode except that the data must be programmed to sectors that are not erase-suspended. Successively reading from the erase-suspended sector while the device is in the erase-suspend-program mode will cause  $DQ_2$  to toggle. The end of the erase-suspended Program operation is detected by the RY/ $\overline{BY}$  output pin,  $\overline{Data}$  polling of  $DQ_7$  or by the Toggle Bit I ( $DQ_6$ ) which is the same as the regular Program operation. Note that  $DQ_7$  must be read from the Program address while  $DQ_6$  can be read from any address within bank being erase-suspended.

To resume the operation of Sector Erase, the Resume command (30h) should be written to the bank being erase suspended. Any further writes of the Resume command at this point will be ignored. Another Erase Suspend command is written after the chip has resumed erasing.

#### **Extended Command**

#### (1) Fast Mode

The device has Fast Mode function. This mode dispenses with the initial two unclock cycles required in the standard program command sequence by writing Fast Mode command into the command register. In this mode, the required bus cycle for programming is two cycles instead of four bus cycles in standard program command. (Do not write erase command in this mode.) The read operation is also executed after exiting this mode. In continuous mode, do not write any command other than the continuous program/continuous mode reset command. To exit this mode, it is necessary to write Fast Mode Reset command into the command register. The first cycle must contain the bank address. (Refer to "Embedded Program™ Algorithm for Fast Mode" in "■FLOW CHARTS".) The Vcc active current is required even  $\overline{CE} = V_{IH}$  during Fast Mode.

#### (2) Fast Programming

During Fast Mode, the programming can be executed with two bus cycles operation. The Embedded Program Algorithm is executed by writing program set-up command (A0h) and data write cycles (PA/PD). (Refer to "Embedded Program™ Algorithm for Fast Mode" in "■FLOW CHARTS".)

### **HiddenROM Region**

The HiddenROM feature provides Flash memory region that the system may access through a new command sequence. This is primarily intended for customers who wish to use an Electronic Serial Number (ESN) in the device with the ESN protected against modification. Once the HiddenROM region is protected, any further modification of that region is not allowed. This ensures the security of the ESN once the product is shipped to the field.

The HiddenROM region is 32 K words in length and is stored at the same address as the 4 KW ×8 sectors. The MBM29PDS322TE occupies the address of the word mode 1F8000h to 1FFFFFh and the MBM29PDS322BE type occupies the address of the word mode 000000h to 007FFFh. After the system writes the Enter HiddenROM command sequence, the system reads the HiddenROM region by using the addresses normally occupied by the boot sectors. That is, the device sends all commands that would normally be sent to the boot sectors to the HiddenROM region. This mode of operation continues until the system issues the Exit HiddenROM command sequence, or until power is removed from the device. On power-up, or following a hardware reset, the device reverts to sending commands to the boot sectors.

When reading the HiddenROM region, either change addresses or change  $\overline{\text{CE}}$  pin from "H" to "L". The same procedure should be taken (changing addresses or  $\overline{\text{CE}}$  pin from "H" to "L") after the system issues the Exit HiddenROM command sequence to read actual data of memory cell.

#### **HiddenROM Entry Command**

The device has HiddenROM area with One Time Protect function. This area is to enter the security code and to unable the change of the code once set. Program/erase is possible in this area until it becomes protected. However once it is protected, it is impossible to unprotect, use this command with caution.

HiddenROM area is 32 K words and in the same address area as 4 KW sector. The address of top boot is 1F8000h to 1FFFFFh at word mode and the bottom boot is 000000h to 007FFFh at word mode. These areas are normally the boot block area (4 KW ×8 sector). Therefore write the HiddenROM entry command sequence to enter the HiddenROM area. This is called HiddenROM mode as the HiddenROM area appears.

Sector other than the boot block area could be read during HiddenROM mode. Read/program/erase of the HiddenROM area is allowed during HiddenROM mode. Write the HiddenROM reset command sequence to exit the HiddenROM mode. The bank address of the HiddenROM should be set on the third cycle of this reset command sequence. Note that any other commands should not be issued than the HiddenROM program/ protection/reset commands during the HiddenROM mode. When you issue the other commands including the suspend resume capability, send the HiddenROM reset command first to exit the HiddenROM mode and then issue each command.

#### **HiddenROM Program Command**

To program data to the HiddenROM area, write the HiddenROM program command sequence during Hidden-ROM mode. This command is the same as the program command in usual except to write the command during HiddenROM mode. Therefore the detection of completion method is the same as described, using the DQ $_7$  data poling, DQ $_6$  toggle bit and RY/BY pin. It is necessary to pay attention to the address to be programmed. If the address other than the HiddenROM area is selected to program, data of the address will be changed. During the write into the HiddenROM region, the program suspend command issuance is prohibited.

#### **HiddenROM Erase Command**

To erase the HiddenROM area, write the HiddenROM erase command sequence during HiddenROM mode. This command is same as the sector erase command in the past except to write the command during HiddenROM mode. Therefore the detection of completion method is the same as in the past, using the  $DQ_7$  data poling,  $DQ_6$  toggle bit and  $RY/\overline{BY}$  pin. It is necessary to pay attention to the sector address to be erased. If the sector address other than the HiddenROM area is selected, the data of the sector will be changed.

#### **HiddenROM Protect Command**

There are two methods to protect the HiddenROM area. One is to write the sector group protect setup command (60h), set the sector address in the HiddenROM area and (A6, A3, A2,A1, A0) = (0,0,0,1,0), and write the sector group protect command (60h) during the HiddenROM mode. The same command sequence could be used because, it is just as the extension sector group protect in the past except that it is in the HiddenROM mode and it does not apply high voltage to  $\overline{RESET}$  pin. Please refer to "Function Explanation Extended Sector Group Protection" for details of extension sector group protect setting.

The other method is to apply high voltage ( $V_{ID}$ ) to  $A_9$  and  $\overline{OE}$ , set the sector address in the HiddenROM area and ( $A_6$ ,  $A_3$ ,  $A_2$ ,  $A_1$ ,  $A_0$ ) = (0, 0, 0, 1, 0), and apply the write pulse during the HiddenROM mode. To verify the protect circuit, apply high voltage ( $V_{ID}$ ) to  $A_9$ , specify ( $A_6$ ,  $A_3$ ,  $A_2$ ,  $A_1$ ,  $A_0$ ) = (0, 0, 0, 1, 0) and the sector address in the HiddenROM area, and read. When "1" appears on DQ<sub>0</sub>, the protect setting is completed. "0" will appear on DQ<sub>0</sub> if it is not protected. Please apply write pulse again. The same command sequence could be used for the above method because other than the HiddenROM mode, it is the same with the sector group protect previously mentioned. Refer to "Function Explanation Sector Group Protection" for details of the sector group protect setting.

Other sector group will be effected if the address other than those for HiddenROM area is selected for the sector group address. Once it is protected, protection cannot be cancelled, so please pay the closest attention.

### **Write Operation Status**

Detailed in "Hardware Sequence Flags" Table are all the status flags that determine the status of the bank for the current mode operation. The read operation from the bank which does not operate Embedded Algorithm returns data of memory cells. These bits offer a method for determining whether a Embedded Algorithm is properly completed. The information on  $DQ_2$  is address sensitive. This means that if an address from an erasing sector is consecutively read, then the  $DQ_2$  bit will toggle. However  $DQ_2$  will not toggle if an address from a non-erasing sector is consecutively read. This allows users to determine which sectors are in erase.

The status flag is not output from bank (non-busy bank) which does not execute Embedded Algorithm. For example, there is bank (busy bank), now executing Embedded Algorithm. When the read sequence is [1] <br/> bank>, [2] <non-busy bank>, [3] <br/> busy bank>, the DQ $_6$  is toggling in the case of [1] and [3]. In case of [2], the data of memory cells are outputted. In the erase-suspend read mode with the same read sequence, DQ $_6$  will not be toggled in the [1] and [3].

In the erase suspend read mode, DQ<sub>2</sub> is toggled in the [1] and [3]. In case of [2], the data of memory cell is outputted.

# **Hardware Sequence Flags Table**

		Status	DQ <sub>7</sub>	DQ <sub>6</sub>	DQ <sub>5</sub>	DQ₃	DQ <sub>2</sub>
	Embedded F	Program Algorithm	DQ <sub>7</sub>	Toggle	0	0	1
	Embedded E	Frase Algorithm	0	Toggle	0	1	Toggle *1
	_	Erase Suspend Read (Erase Suspended Sector)	1	1	0	0	Toggle
In Progress	Erase Suspended Mode	Erase Suspend Read (Non-Erase Suspended Sector)	Data	Data	Data	Data	Data
mr rogroco	mede	Erase Suspend Program (Non-Erase Suspended Sector)	DQ <sub>7</sub>	Toggle	0	0	<b>1</b> *2
	Program Suspende Mode	Program Suspend Read (Program Suspended Sector)	Data	Data	Data	Data	Data
		Program Suspend Read (Non-Program Suspended Sector)	Data	Data	Data	Data	Data
	Embedded F	Program Algorithm	$\overline{DQ}_7$	Toggle	1	0	1
Exceeded	Embedded E	rase Algorithm	0	Toggle	1	1	N/A
Time Limits			<del>DQ</del> 7	Toggle	1	0	N/A

<sup>\*1:</sup> Successive reads from the erasing or erase-suspend sector causes DQ2 to toggle.

<sup>\*2:</sup> Reading from non-erase suspend sector address will indicate logic "1" at the DQ2 bit.

#### DQ<sub>7</sub>

## Data Polling

The device features Data Polling as a method to indicate to the host that the Embedded Algorithms are in progress or completed. During the Embedded Program Algorithm an attempt to read device will produce a complement of data last written to DQ<sub>7</sub>. Upon completion of the Embedded Program Algorithm, an attempt to read device will produce true data last written to DQ<sub>7</sub>. During the Embedded Erase Algorithm, an attempt to read device will produce a "0" at the DQ<sub>7</sub> output. Upon completion of the Embedded Erase Algorithm an attempt to read device will produce a "1" on DQ<sub>7</sub>. The flowchart for Data Polling (DQ<sub>7</sub>) is shown in "Toggle Bit Algorithm" in "■FLOW CHARTS".

For programming, the Data Polling is valid after the rising edge of the fourth write pulse in the four write pulse sequence.

For chip erase and sector erase, the Data Polling is valid after the rising edge of the sixth write pulse in the six write pulse sequence. Data Polling must be performed at sector address of sectors being erased, not protected sectors. Otherwise, the status may be invalid.

If a program address falls within a protected sector,  $\overline{\text{Data}}$  Polling on DQ<sub>7</sub> is active for approximately 1 µs, then that bank returns to the read mode. After an erase command sequence is written, if all sectors selected for erasing are protected,  $\overline{\text{Data}}$  Polling on DQ<sub>7</sub> is active for approximately 400 µs, then the bank returns to read mode.

Once the Embedded Algorithm operation is close to completion, the device data pins  $(DQ_7)$  may change asynchronously while the output enable  $(\overline{OE})$  is asserted low. This means that device is driving status information on  $DQ_7$  at one instant of time and then that byte's valid data at the next instant of time. Depending on when the system samples the  $DQ_7$  output, it may read the status or valid data. Even if device has completed the Embedded Algorithm operation and  $DQ_7$  has a valid data, data outputs on  $DQ_0$  to  $DQ_6$  may be still invalid. The valid data on  $DQ_0$  to  $DQ_7$  will be read on the successive read attempts.

The Data Polling feature is active only during the Embedded Programming Algorithm, Embedded Erase Algorithm or sector erase time-out. (See "Hardware Sequence Flags" Table.)

See "Toggle Bit I during Embedded Algorithm Operation Timing Diagram" in "■TIMING DIAGRAM" for the Data Polling timing specifications and diagrams.

## $DQ_6$

#### Toggle Bit I

The device also features the "Toggle Bit I" as a method to indicate to the host system that the Embedded Algorithms are in progress or completed.

During Embedded Program or Erase Algorithm cycle, successive attempts to read ( $\overline{OE}$  toggling) data from the device will results in DQ $_6$  toggling between one and zero. Once the Embedded Program or Erase Algorithm cycle is completed, DQ $_6$  will stop toggling and valid data will be read on the next successive attempts. During programming, the Toggle Bit I is valid after the rising edge of the fourth write pulse in the four write pulse sequence. For chip erase and sector erase, the Toggle Bit I is valid after the rising edge of the sixth write pulse in the six write pulse sequence. The Toggle Bit I is active during the sector time out.

In programming, if the sector being written is protected, the toggle bit will toggle for about 1  $\mu$ s and then stop toggling with data unchanged. In erase, device will erase all selected sectors except for ones that are protected. If all selected sectors are protected, the chip will toggle the toggle bit for about 400  $\mu$ s and then drop back into read mode, having data unchanged.

Either  $\overline{CE}$  or  $\overline{OE}$  toggling will cause DQ<sub>6</sub> to toggle. In addition, an Erase Suspend/Resume command will cause DQ<sub>6</sub> to toggle.

The system can use  $DQ_6$  to determine whether a sector is actively erased or is erase-suspended. When a bank is actively erased (that is, the Embedded Erase Algorithm is in progress),  $DQ_6$  toggles. When a bank enters the Erase Suspend mode,  $DQ_6$  stops toggling. Successive read cycles during erase-suspend-program cause  $DQ_6$  to toggle.

To operate toggle bit function properly,  $\overline{\text{CE}}$  or  $\overline{\text{OE}}$  must be high when bank address is changed.

See "Bank-to-Bank Read/Write Timing Diagram" in "■TIMING DIAGRAM" for the Toggle Bit I timing specifications and diagrams.

#### $DQ_5$

#### **Exceeded Timing Limits**

 $DQ_5$  will indicate if the program or erase time has exceeded the specified limits (internal pulse count). Under these conditions  $DQ_5$  will produce a "1". This is a failure condition which indicates that the program or erase cycle was not successfully completed.  $\overline{Data}$  Polling is the only operating function of device under this condition. The  $\overline{CE}$  circuit will partially power down device under these conditions (to approximately 2 mA). The  $\overline{OE}$  and  $\overline{WE}$  pins will control the output disable functions as described in "Simultaneous Operation" Table in " $\blacksquare FUNC-TIONAL$  DESCRIPTION".

The  $DQ_5$  failure condition may also appear if a user tries to program a non blank location without pre-erase. In this case the device locks out and never complete the Embedded Algorithm operation. Hence, the system never read valid data on  $DQ_7$  bit and  $DQ_6$  never stop toggling. Once device has exceeded timing limits, the  $DQ_5$  bit will indicate a "1." Please note that this is not a device failure condition since device was incorrectly used. If this occurs, reset device with command sequence.

#### DQ<sub>3</sub>

#### Sector Erase Timer

After completion of the initial sector erase command sequence sector erase time-out will begin. DQ₃ will remain low until the time-out is completed. Data Polling and Toggle Bit are valid after the initial sector erase command sequence.

If  $\overline{Data}$  Polling or the Toggle Bit I indicates device has been written with a valid erase command,  $DQ_3$  may be used to determine if the sector erase timer window is still open. If  $DQ_3$  is high ("1") the internally controlled erase cycle has begun.If  $DQ_3$  is low ("0"), the device will accept additional sector erase commands. To insure the command has been accepted, the system software should check the status of  $DQ_3$  prior to and following each subsequent Sector Erase command. If  $DQ_3$  were high on the second status check, the command may not have been accepted.

See "Hardware Sequence Flags" Table.

## $DQ_2$

## Toggle Bit II

This toggle bit II, along with DQ6, can be used to determine whether the device is in the Embedded Erase Algorithm or in Erase Suspend.

Successive reads from the erasing sector will cause  $DQ_2$  to toggle during the Embedded Erase Algorithm. If the device is in the erase-suspended-read mode, successive reads from the erase-suspended sector will cause  $DQ_2$  to toggle. When the device is in the erase-suspended-program mode, successive reads from the word address of the non-erase suspended sector will indicate a logic "1" at the  $DQ_2$  bit.

 $DQ_6$  is different from  $DQ_2$  in that  $DQ_6$  toggles only when the standard program or Erase, or Erase Suspend Program operation is in progress. The behavior of these two status bits, along with that of  $DQ_7$ , is summarized as follows:

For example,  $DQ_2$  and  $DQ_6$  can be used together to determine if the erase-suspend-read mode is in progress. ( $DQ_2$  toggles while  $DQ_6$  does not.) See also and.

Furthermore,  $DQ_2$  can also be used to determine which sector is being erased. When device is in the erase mode,  $DQ_2$  toggles if this bit is read from an erasing sector.

To operate toggle bit function properly,  $\overline{CE}$  or  $\overline{OE}$  must be high when bank address is changed.

### Reading Toggle Bits DQ6/DQ2

Whenever the system initially begins reading toggle bit status, it must read  $DQ_7$  to  $DQ_0$  at least twice in a row to determine whether a toggle bit is toggling. Typically, a system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on  $DQ_7$  to  $DQ_0$  on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of  $DQ_5$  is high (see the section on  $DQ_5$ ). If it is the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as  $DQ_5$  went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not complete the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ₅ has not gone high. The system may continue to monitor the toggle bit and DQ₅ through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation. (Refer to "Toggle Bit Algorithm" in "■FLOW CHARTS".)

## **Toggle Bit Status Table**

Mode	DQ <sub>7</sub>	DQ <sub>6</sub>	DQ₂
Program	<del>DQ</del> 7	Toggle	1
Erase	0	Toggle	Toggle *1
Erase-Suspend Read (Erase-Suspended Sector)	1	1	Toggle
Erase-Suspend Program	<del>DQ</del> 7	Toggle	1 *2

<sup>\*1:</sup> Successive reads from the erasing or erase-suspend sector will cause DQ2 to toggle.

#### RY/BY

## Ready/Busy

The device provides a RY/BY open-drain output pin as a way to indicate to the host system that Embedded Algorithms are either in progress or has been completed. If output is low, device is busy with either a program or erase operation. If output is high, device is ready to accept any read/write or erase operation. If the device is placed in an Erase Suspend mode, RY/BY output will be high.

During programming, RY/BY pin is driven low after the rising edge of the fourth write pulse. During an erase operation, RY/BY pin is driven low after the rising edge of the sixth write pulse. RY/BY pin will indicate a busy condition during RESET pulse. Refer to "RY/BY Timing Diagram during Program/Erase Operation Timing Diagram" and "RESET, RY/BY Timing Diagram" in "TIMING DIAGRAM" for a detailed timing diagram. RY/BY pin is pulled high in standby mode.

Since this is an open-drain output, the pull-up resistor needs to be Vcc; multiples of devices may be connected to the best system via more than one RY/ $\overline{BY}$  pin in parallel.

<sup>\*2:</sup> Reading from the non-erase suspend sector address will indicate logic "1" at the DQ2 bit.

#### **Data Protection**

The device is designed to offer protection against accidental erasure or programming caused by spurious system level signals that may exist during power transitions. During power up device automatically resets internal state machine in Read mode. Also, with its control register architecture, alteration of memory contents only occurs after successful completion of specific multi-bus cycle command sequences.

The device also incorporates several features to prevent inadvertent write cycles resulting from Vcc power-up and power-down transitions or system noise.

## **Power On/Off Timing**

The RESET pin must be held low during Vcc ramp up to insure that device power up correctly. (Refer to "Page Read Operation Timing Diagram" in "■TIMING DIAGRAM".)

#### Write Pulse "Glitch" Protection

Noise pulses of less than 3 ns (typical) on  $\overline{OE}$ ,  $\overline{CE}$  or  $\overline{WE}$  will not initiate a write cycle.

#### **Logical Inhibit**

Writing is inhibited by holding any one of  $\overline{OE} = V_{IL}$ ,  $\overline{CE} = V_{IH}$ , or  $\overline{WE} = V_{IH}$ . To initiate a write cycle  $\overline{CE}$  and  $\overline{WE}$  must be a logical zero while  $\overline{OE}$  is a logical one.

## **Power-Up Write Inhibit**

Power-up of the device with  $\overline{WE} = \overline{CE} = V_{IL}$  and  $\overline{OE} = V_{IH}$  will not accept commands on the rising edge of  $\overline{WE}$ . The internal state machine is automatically reset to the read mode on power-up.

#### **Sector Protection**

Device user is able to protect each sector group individually to store and protect data.

Protection circuit voids both write and erase commands that are addressed to protected sectors.

Any commands to write or erase addressed to protected sector are ignore (see "Sector Group Protection" in "EFUNCTIONAL DESCRIPTION").

## ■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rat	Unit	
Farameter	Syllibol	Min	Max	Offic
Storage Temperature	Tstg	<del>-</del> 55	+125	°C
Ambient Temperature with Power Applied	TA	-40	+85	°C
Voltage with Respect to Ground All pins except A <sub>9</sub> , OE, and RESET *1	VIN, VOUT	-0.5	Vcc+0.5	V
Power Supply Voltage *1	Vcc	-0.5	+2.7	V
A <sub>9</sub> , $\overline{\text{OE}}$ , and $\overline{\text{RESET}}^{*2}$	Vin	-0.5	+11.0	V
WP/ACC *3	VACC	-0.5	+12.6	V

- \*1: Minimum DC voltage on input or I/O pins is –0.5 V. During voltage transitions, input or I/O pins may undershoot Vss to –2.0 V for periods of up to 20 ns. Maximum DC voltage on input or I/O pins is Vcc +0.5 V. During voltage transitions, input or I/O pins may overshoot to Vcc +2.0 V for periods of up to 20 ns.
- \*2: Minimum DC input voltage on A<sub>9</sub>,  $\overline{\text{OE}}$  and  $\overline{\text{RESET}}$  pins is -0.5 V. During voltage transitions, A<sub>9</sub>,  $\overline{\text{OE}}$  and  $\overline{\text{RESET}}$  pins may undershoot V<sub>SS</sub> to -2.0 V for periods of up to 20 ns. Voltage difference between input and supply voltage (V<sub>IN</sub>-V<sub>CC</sub>) does not exceed +9.0V. Maximum DC input voltage on A<sub>9</sub>,  $\overline{\text{OE}}$  and  $\overline{\text{RESET}}$  pins is +11.0 V which may positive overshoot to +12.5 V for periods of up to 20 ns.
- \*3: Minimum DC input voltage on WP/ACC pin is -0.5 V. During voltage transitions, WP/ACC pin may undershoot Vss to -2.0 V for periods of up to 20 ns. Maximum DC input voltage on WP/ACC pin is +12.6 V which may positive overshoot to +13.0 V for periods of up to 20ns when Vcc is applied.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

## ■ RECOMMENDED OPERATING RANGES

Parameter	Symbol	Va	Unit	
Farameter	Symbol	Min	Max	Offic
Ambient Temperature	TA	-40	+85	°C
Power Supply Voltage	Vcc	+1.8	+2.2	V

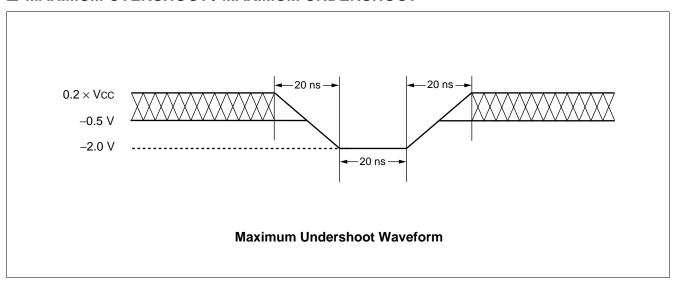
Note: Operating ranges define those limits between which the functionality of the device is guaranteed.

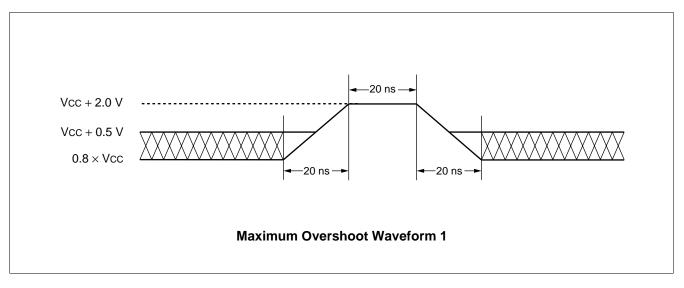
WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

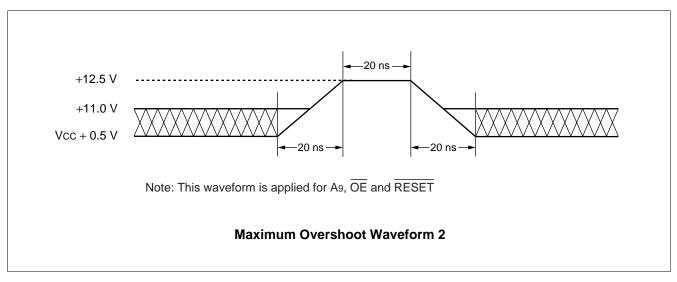
Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representatives beforehand.

#### ■ MAXIMUM OVERSHOOT / MAXIMUM UNDERSHOOT







#### **■ ELECTRICAL CHARACTERISTICS**

#### 1. DC Characteristics

Devementer	Cumbal	Conditions	Va	11!4	
Parameter	Symbol	Conditions	Min	Max	Unit
Input Leakage Current	lы	V <sub>IN</sub> = V <sub>SS</sub> to V <sub>CC</sub> , V <sub>CC</sub> = V <sub>CC</sub> Max	-1.0	+1.0	μΑ
Output Leakage Current	ILO	Vout = Vss to Vcc, Vcc = Vcc Max	-1.0	+1.0	μΑ
A <sub>9</sub> , OE, RESET Inputs Leakage Current	Ішт	Vcc = Vcc Max , A <sub>9</sub> , <del>OE</del> , <del>RESET</del> = 11.0 V	_	35	μΑ
Vcc Active Current *1	Icc1	CE = VIL, OE = VIH, f = 10 MHz	_	28	mA
VCC Active Current	ICC1	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}, f = 1 \text{ MHz}$	_	3	mA
Vcc Active Current *2	Icc2	CE = VIL, OE = VIH	_	30	mA
Vcc Current (Standby)	Іссз	$Vcc = Vcc Max, \overline{CE} = Vcc \pm 0.3 V, \overline{RESET} = Vcc \pm 0.3 V$	_	5	μΑ
Vcc Current (Standby, Reset)	Icc4	$Vcc = Vcc Max, \overline{WE}/ACC = Vcc \pm 0.3 V, \overline{RESET} = Vss \pm 0.3 V$	_	5	μΑ
Vcc Current (Automatic Sleep Mode) *3	Icc5		_	5	μΑ
Vcc Active Current *5 (Read-While-Program)	Icc <sub>6</sub>	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$	_	55	mA
Vcc Active Current *5 (Read-While-Erase)	Ісст	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$	_	55	mA
Vcc Active Current (Erase-Suspend-Program)	Icc8	$\overline{CE} = V_{IL}, \overline{OE} = V_{IH}$	_	35	mA
WP/ACC Accelerated Program Current	lacc	Vcc = Vcc Max, WP/ACC = Vacc Max	_	20	mA
Input Low Level	VIL	_	-0.5	0.2× Vcc	V
Input High Level	VIH	_	0.8× Vcc	Vcc+0.3	V
Voltage for WP/ACC Sector Protection/Unprotection and Program Acceleration *4	Vacc	_	8.5	12.5	V
Voltage for Autoselect and Sector Protection (A <sub>9</sub> , OE, RESET) *4	VID	_	10.0	11.0	V
Output Low Voltage Level	Vol	$IoL = 100 \mu A$ , $Vcc = Vcc Min$	_	0.1	V
Output High Voltage Level	Vон	Іон = -100 μА	Vcc-0.1	_	V
Low Vcc Lock-Out Voltage	VLKO	_	1.2	1.5	V

<sup>\*1:</sup> The loc current listed includes both the DC operating current and the frequency dependent component.

<sup>\*2:</sup> Icc is active while Embedded Algorithm (program or erase) is in progress.

<sup>\*3:</sup> Automatic sleep mode enables the low power mode when address remains stable for 150 ns.

<sup>\*4:</sup> Applicable for only Vcc applying.

<sup>\*5:</sup> Embedded Algorithm (program or erase) is in progress. (@5 MHz)

#### 2. AC Characteristics

#### • Read Only Operations Characteristics

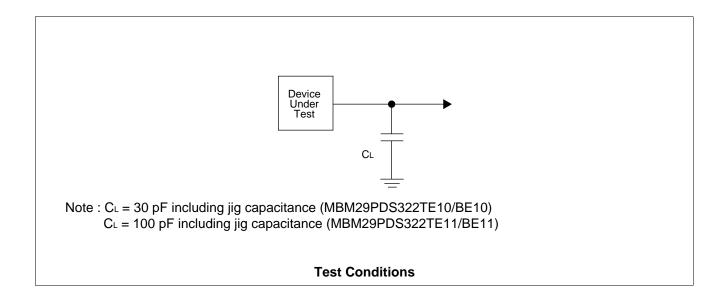
	Symbol			Value(Note)				
Parameter			Conditions	10		11		Unit
	JEDEC	Standard		Min	Max	Min	Max	
Read Cycle Time	<b>t</b> avav	<b>t</b> RC	_	100		115	_	ns
Address to Output Delay	tavqv	tacc	CE = VIL, OE = VIL		100		115	ns
Page Read Cycle Time	_	<b>t</b> PRC	_	40	_	50	_	ns
Page Address to Output Delay	_	<b>t</b> PACC	<u>CE</u> = V <sub>IL</sub> , <u>OE</u> = V <sub>IL</sub>	—	40	—	50	ns
Chip Enable to Output Delay	<b>t</b> ELQV	<b>t</b> ce	OE = VIL	_	100	_	115	ns
Output Enable to Output Delay	<b>t</b> GLQV	<b>t</b> oe	_	_	35	_	45	ns
Chip Enable to Output High-Z	<b>t</b> ehqz	<b>t</b> DF	_	_	30	_	30	ns
Output Enable to Output High-Z	<b>t</b> GHQZ	<b>t</b> DF	_		30		30	ns
Output Hold Time From Addresses, CE or OE, Whichever Occurs First	taxqx	tон	_	0		0	_	ns
RESET Pin Low to Read Mode	_	<b>t</b> READY	_		20		20	μs

Note: Test Conditions:

Output Load: 30 pF (MBM29PDS322TE10/BE10) 100 pF (MBM29PDS322TE11/BE11)

Input rise and fall times: 5 ns Input pulse levels: 0.0 V or 2.0 V Timing measurement reference level

Input: 1.0 V Output: 1.0 V



• Write/Erase/Program Operations

		Symbol		Value						
	Parameter	Syr	nboi		10			11		Unit
		JEDEC	Standard	Min	Тур	Max	Min	Тур	Max	
Write Cycle Tin	ne	tavav	twc	100	_	_	115	_	_	ns
Address Setup	Time	tavwl	<b>t</b> AS	0	_	_	0	_	_	ns
Address Setup Toggle Bit Polli	Time to OE Low During ng	_	<b>t</b> ASO	15	_		15	_	_	ns
Address Hold T	ime	twlax	<b>t</b> ah	60		_	60		_	ns
Address Hold T During Toggle	ime from CE or OE High Bit Polling	_	<b>t</b> aht	0	_	_	0	_		ns
Data Setup Tim	ne	<b>t</b> dvwh	<b>t</b> DS	60		_	60		_	ns
Data Hold Time	)	<b>t</b> whdx	<b>t</b> DH	0	_	_	0	_	_	ns
Output Enable	Read		<b>t</b>	0	_	_	0	_	_	ns
Hold Time	Toggle and Data Polling	<b> </b>	<b>t</b> oeh -	10	_	_	10	_	_	ns
CE High During	Toggle Bit Polling	_	<b>t</b> CEPH	20	_	_	20	_	_	ns
OE High During	Toggle Bit Polling	_	<b>t</b> oeph	20	_	_	20	_	_	ns
Read Recover	Time Before Write	<b>t</b> GHWL	<b>t</b> GHWL	0		_	0	_	_	ns
Read Recover	Time Before Write	<b>t</b> GHEL	<b>t</b> GHEL	0	_	_	0	_	_	ns
CE Setup Time		<b>t</b> ELWL	<b>t</b> cs	0	_	_	0	_	_	ns
WE Setup Time	)	twlel	tws	0	_	_	0	_	_	ns
CE Hold Time		twheh	<b>t</b> cH	0	_	_	0	_	_	ns
WE Hold Time		<b>t</b> ehwh	twн	0	_	_	0	_	_	ns
Write Pulse Wi	dth	twlwh	twp	60	_	_	60	_	_	ns
CE Pulse Width	1	<b>t</b> eleh	<b>t</b> CP	60	_	_	60	_	_	ns
Write Pulse Wi	dth High	twhwl	<b>t</b> wph	60	_	_	60	_	_	ns
CE Pulse Width	n High	<b>t</b> ehel	<b>t</b> cph	60	_	_	60	_	_	ns
Programming C	Operation	twhwh1	<b>t</b> whwh1	_	16	_	_	16	_	μs
Sector Erase C	peration *1	twhwh2	<b>t</b> whwh2	_	1	_	_	1	_	S
Vcc Setup Time	)	_	tvcs	50	_	_	50	_	_	μs
Rise Time to Vi	D *2		tvidr	500	_	_	500	_	_	ns
Rise Time to V	ACC *3		tvaccr	500	_	_	500		_	ns
Voltage Transit	ion Time *2	_	<b>t</b> vlht	4	_		4		_	μs
Write Pulse Wi	dth *2	_	twpp	100	_	_	100	_	_	μs
OE Setup Time	to WE Active *2	_	toesp	4	_	_	4	_	_	μs

(Continued)

#### (Continued)

	Symbol		Value						
Parameter			10			11			Unit
	JEDEC	Standard	Min	Тур	Max	Min	Тур	Max	
CE Setup Time to WE Active *2	_	<b>t</b> csp	4	_	_	4	_	_	μs
Recover Time from RY/BY	_	<b>t</b> RB	0	_	_	0	_	_	ns
RESET Pulse Width	_	<b>t</b> RP	500	_		500	_	_	ns
RESET High Level Period Before Read	_	<b>t</b> RH	200	_	_	200	_	_	ns
Program/Erase Valid to RY/BY Delay	_	<b>t</b> BUSY	_	_	90	_	_	90	ns
Delay Time from Embedded Output Enable	_	<b>t</b> eoe	_	_	100	_	_	115	ns
Erase Time-out Time	_	<b>t</b> TOW	50	_		50	_	_	μs
Erase Suspend Transition Time	_	<b>t</b> spd	_	_	20	_	_	20	μs
Power On / Off Time	_	<b>t</b> PS	_	_	100	_	_	115	ns

<sup>\*1:</sup> This does not include the preprogramming time.

<sup>\*2:</sup> This timing is for Sector Group Protection operation.

<sup>\*3:</sup> This timing is for Accelerated Program operation.

#### **■ ERASE AND PROGRAMMING PERFORMANCE**

Parameter	Parameter Limits Uni		Unit	Comments	
raiailletei	Min	Тур	Max	Oilit	Comments
Sector Erase Time	_	1	10	s	Excludes programming time prior to erasure
Word Programming Time	_	16	360	μs	Excludes system-level overhead
Chip Programming Time	_	_	100	S	Excludes system-level overhead
Program/Erase Cycle	100,000		_	cycle	_

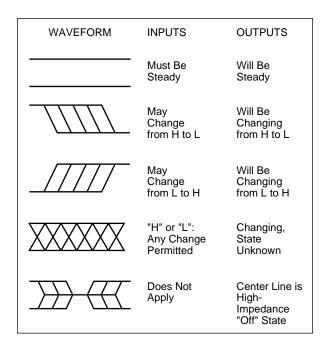
#### **FBGA PIN CAPACITANCE**

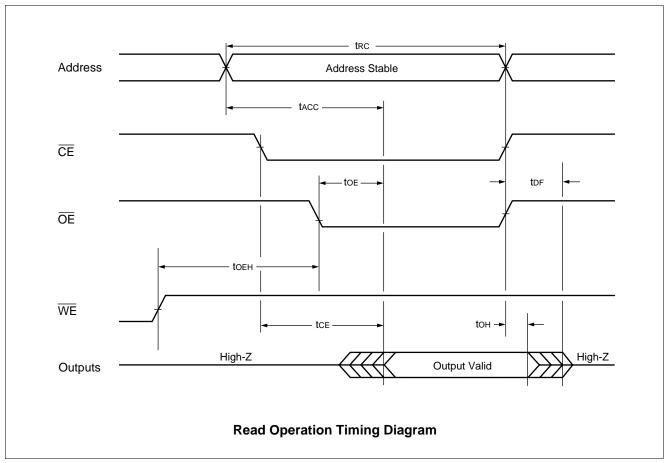
Parameter	Symbol	Condition	Va	Unit		
raiametei	Symbol	Condition	Тур	Max	Oilit	
Input Capacitance	Cin	V <sub>IN</sub> = 0	6.0	7.5	pF	
Output Capacitance	Соит	Vout = 0	8.5	12.0	pF	
Control Pin Capacitance	C <sub>IN2</sub>	V <sub>IN</sub> = 0	7.5	9.0	pF	
WP/ACC Pin Capacitance	Сімз	V <sub>IN</sub> = 0	13.0	16.0	pF	

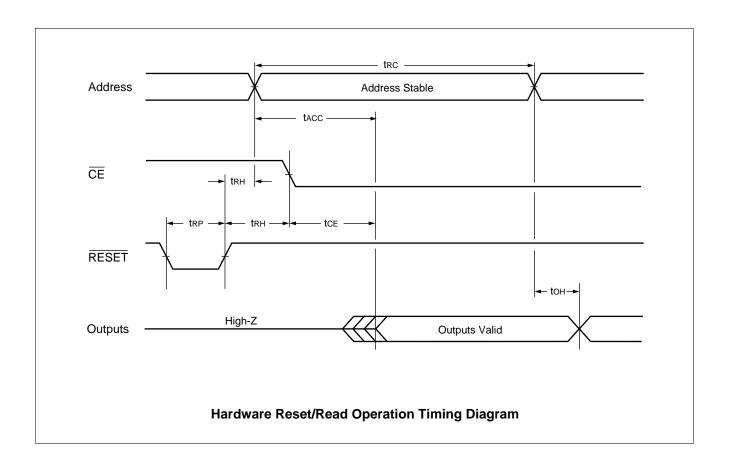
Note: Test conditions T<sub>A</sub> = 25°C, f = 1.0 MHz

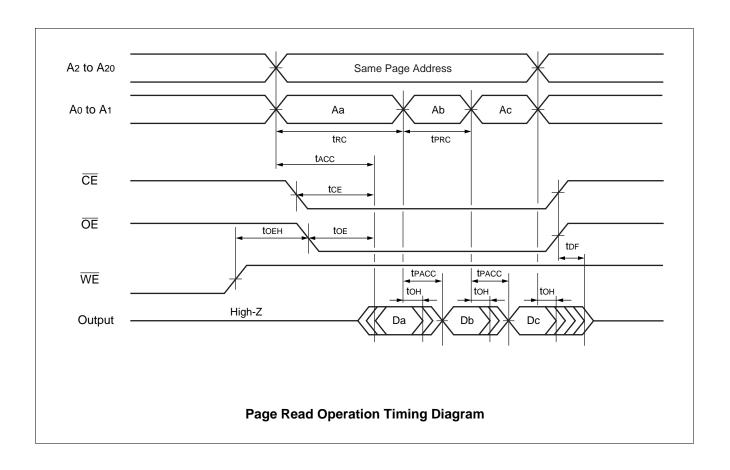
#### **■ TIMING DIAGRAM**

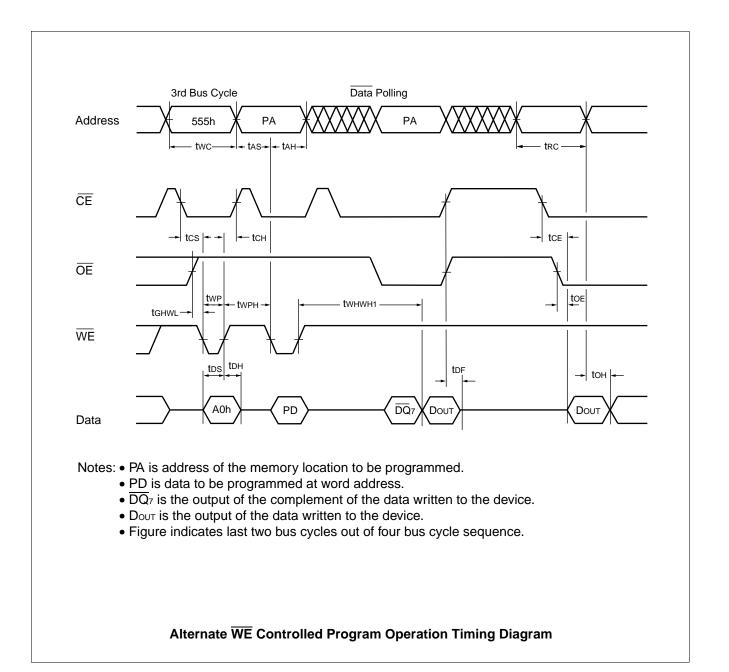
• Key to Switching Waveforms

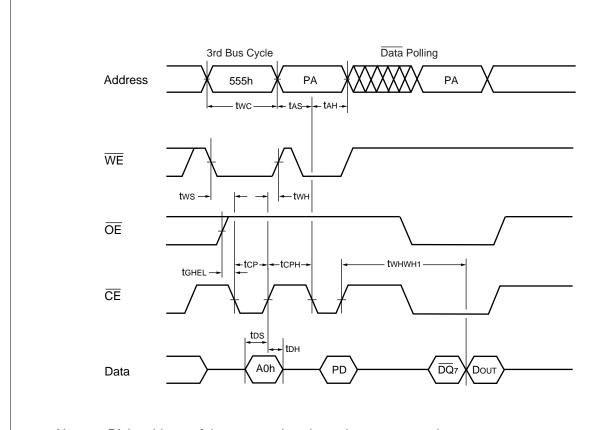








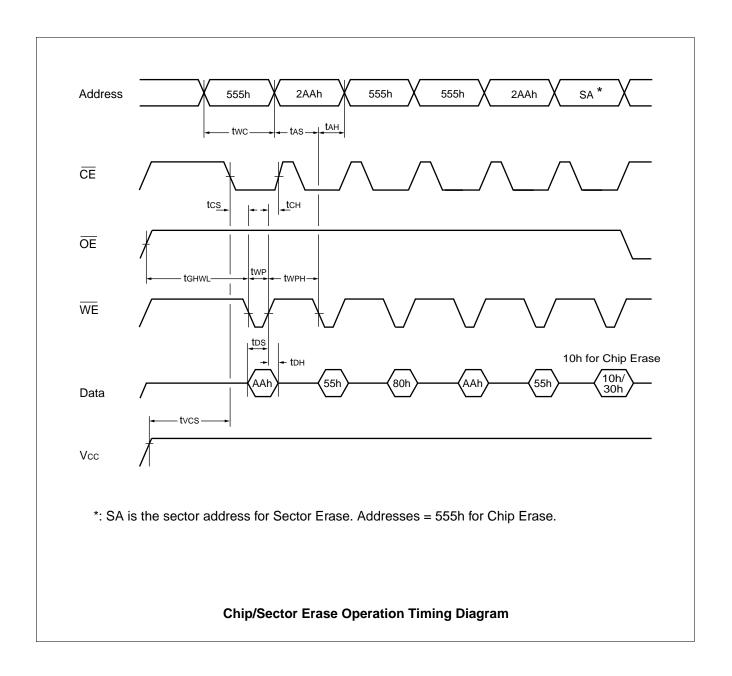


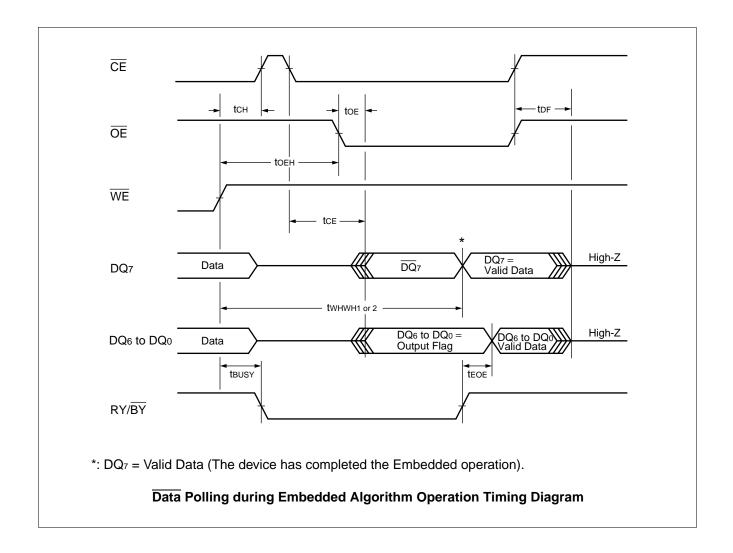


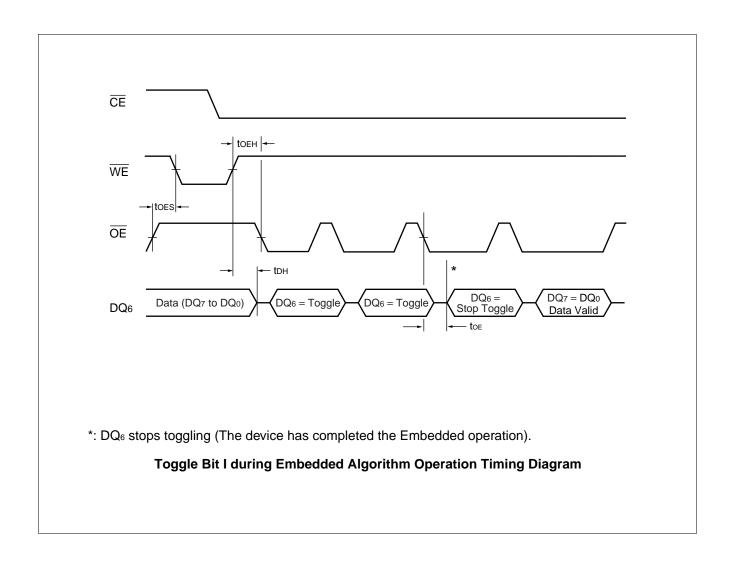
Notes: • PA is address of the memory location to be programmed.

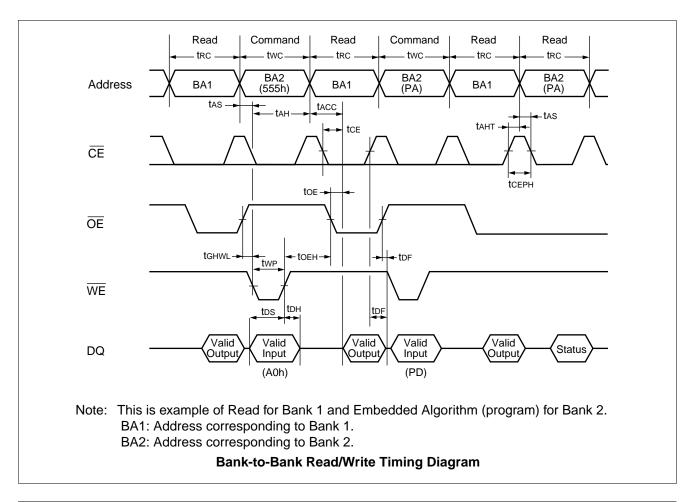
- PD is data to be programmed at word address.
- $\overline{DQ}_7$  is the output of the complement of the data written to the device.
- Dout is the output of the data written to the device.
- Figure indicates last two bus cycles out of four bus cycle sequence.

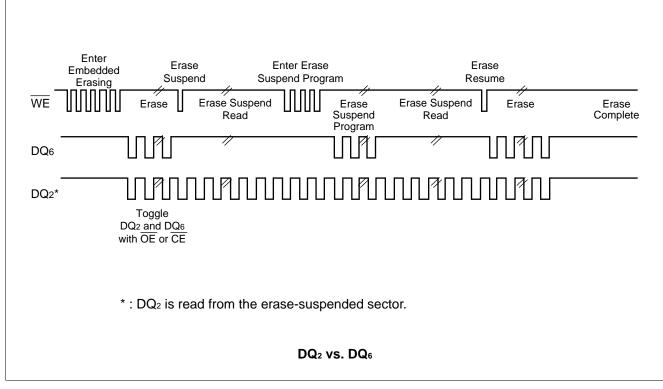
**Alternate CE Controlled Program Operation Timing Diagram** 

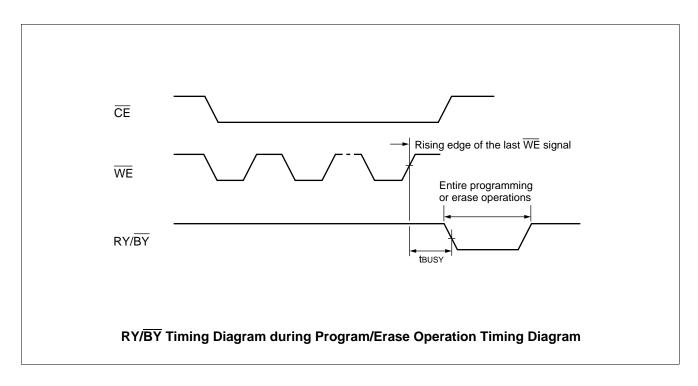


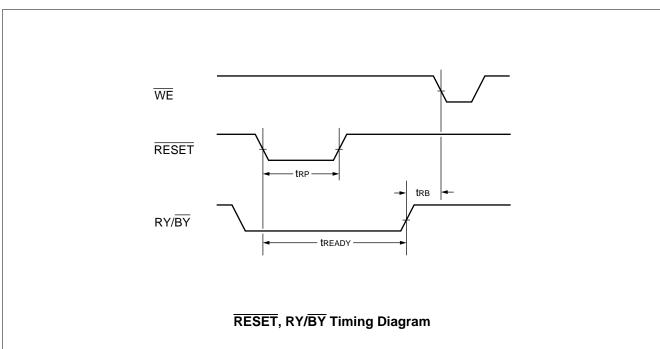


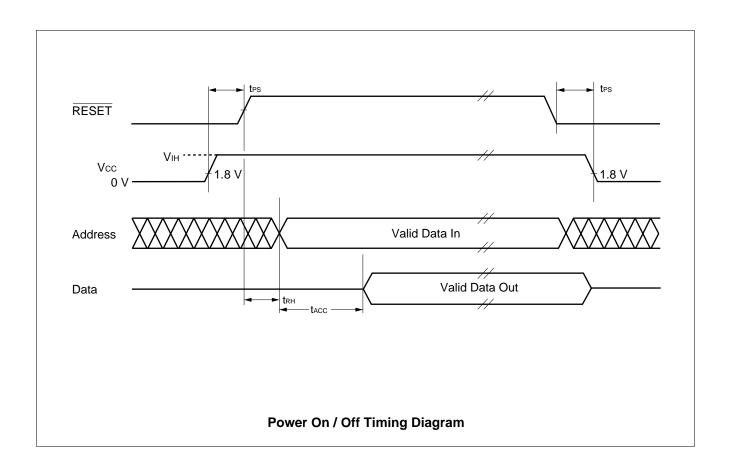


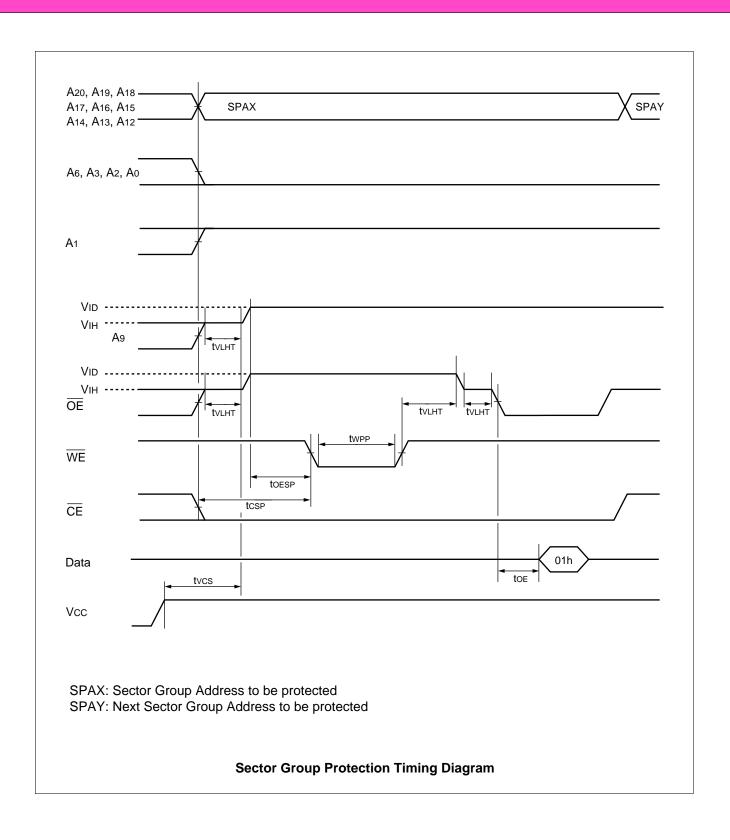


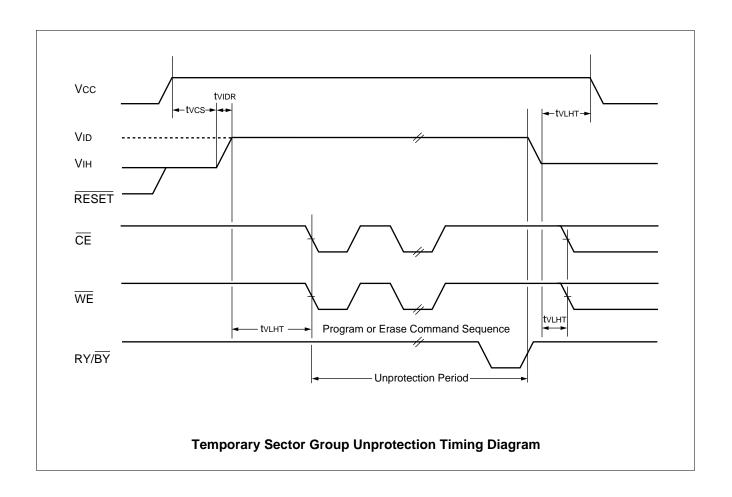


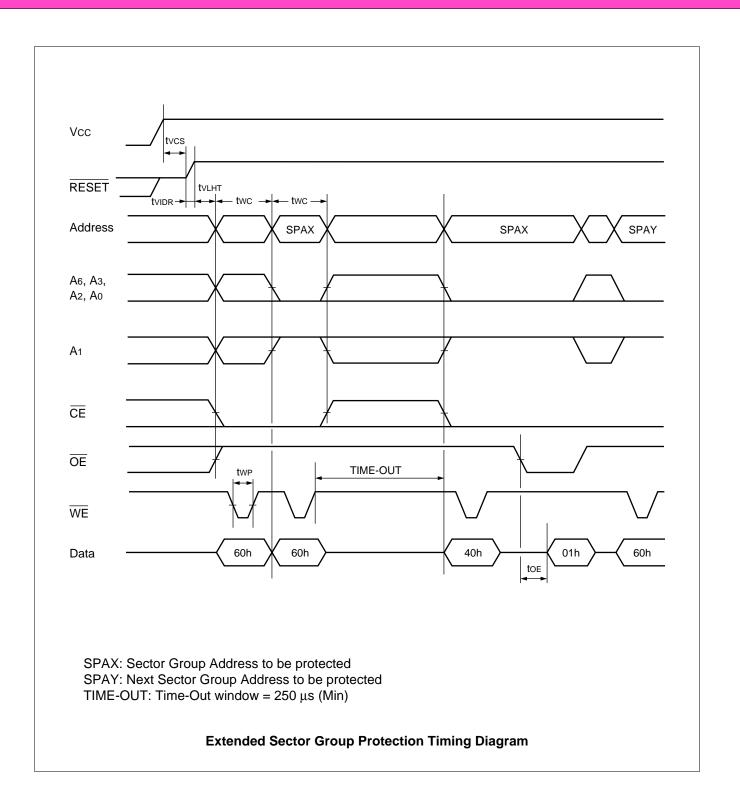


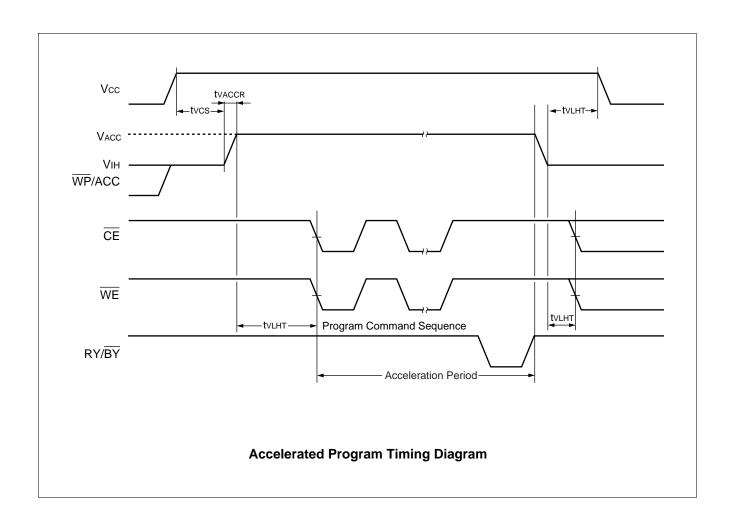




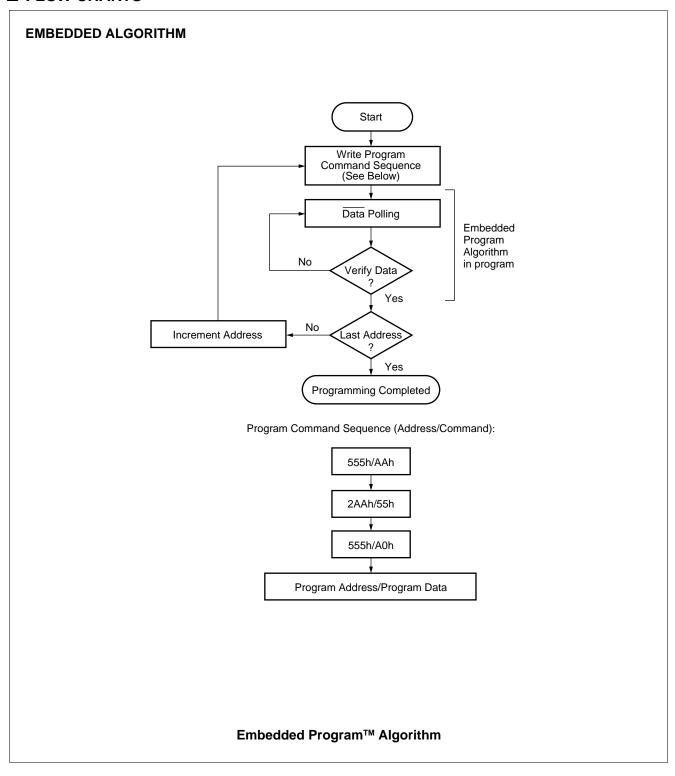


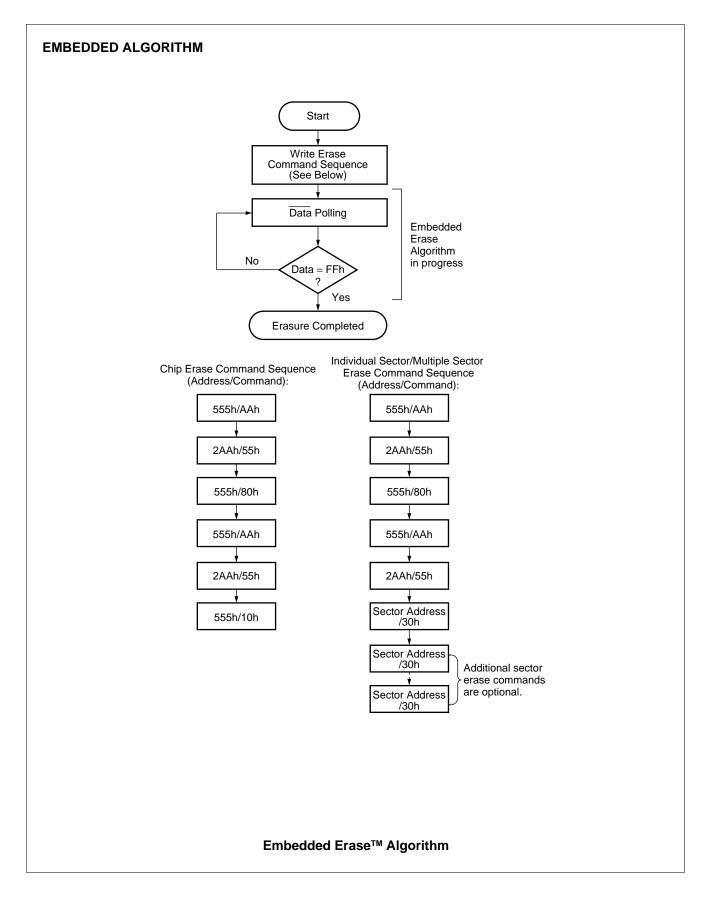


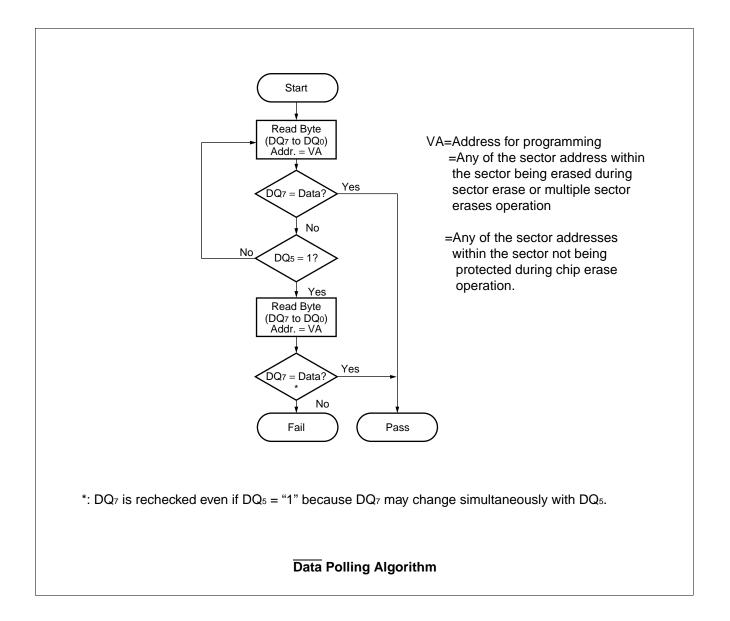


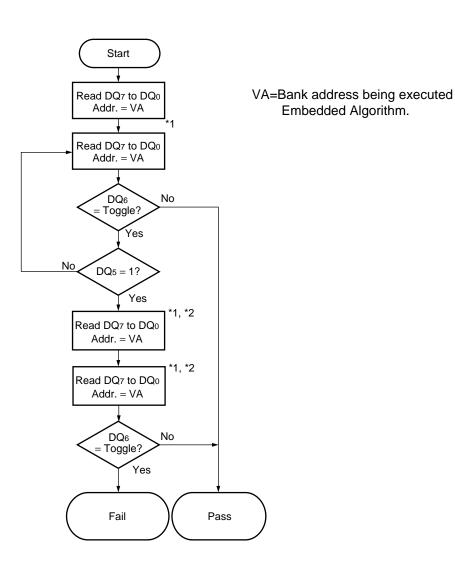


#### **■ FLOW CHARTS**





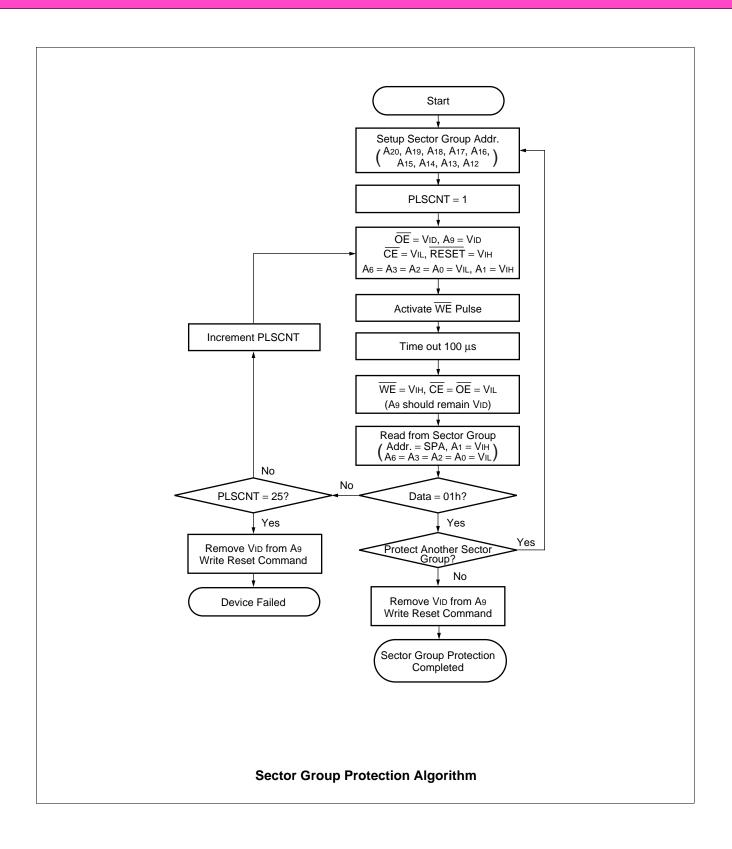


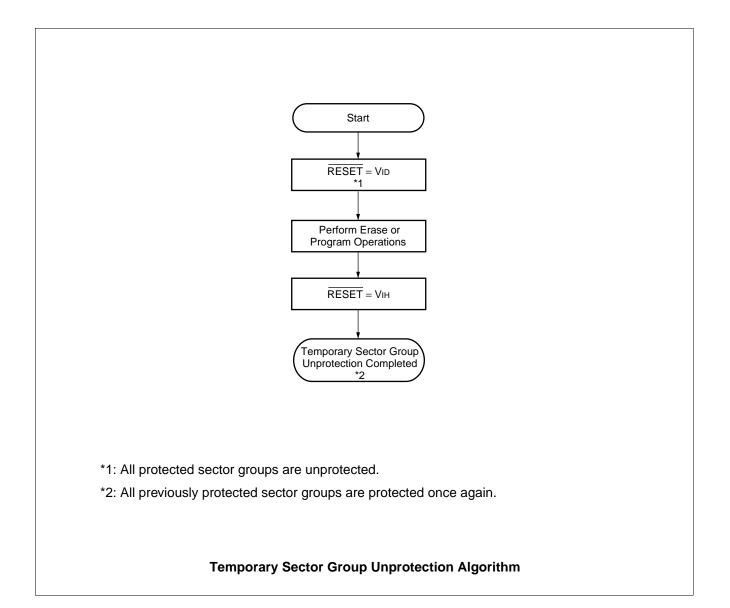


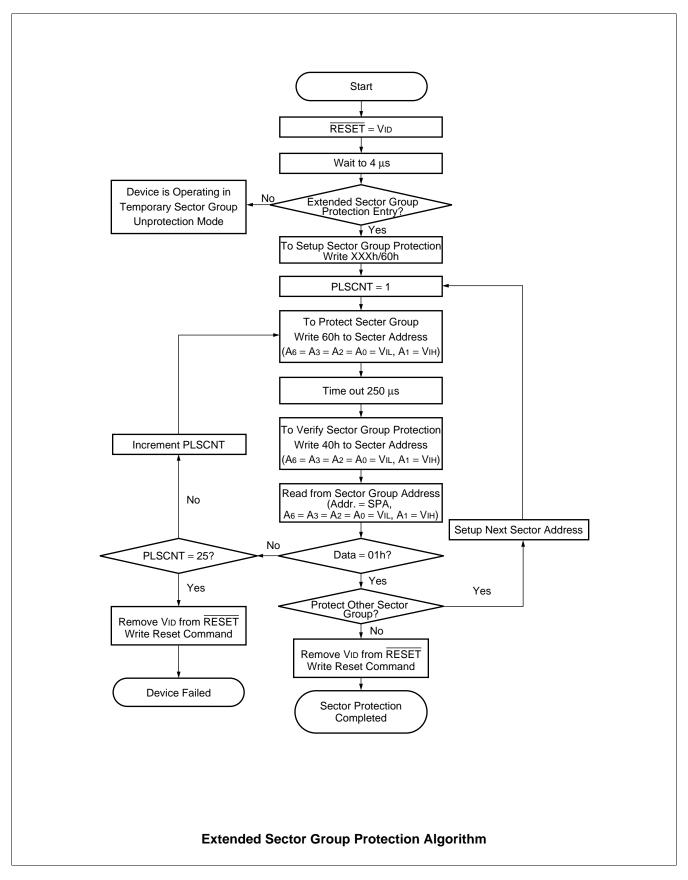
\*1: Read toggle bit twice to determine whether it is toggling.

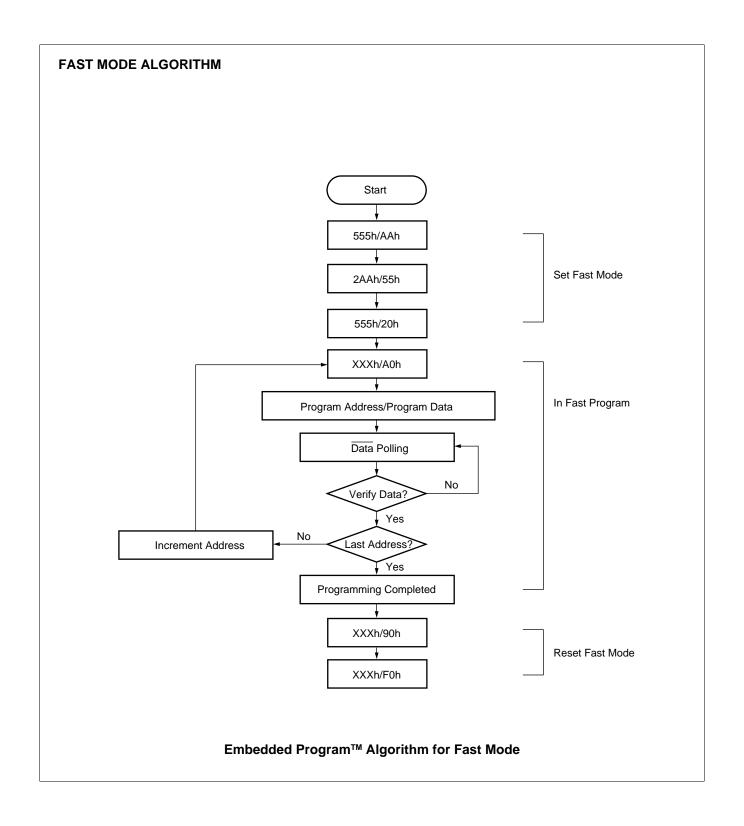
\*2: Recheck toggle bit because it may stop toggling as DQ₅ changes to "1".

**Toggle Bit Algorithm** 



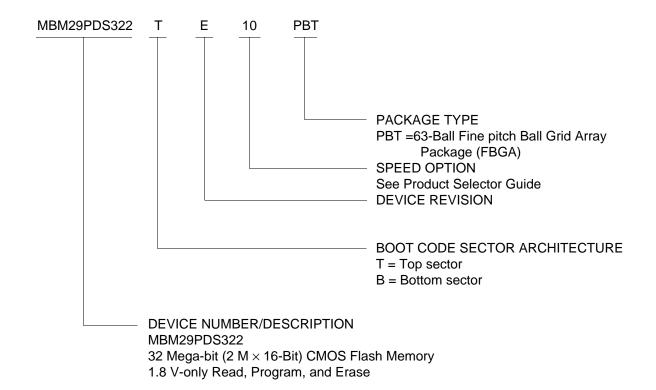




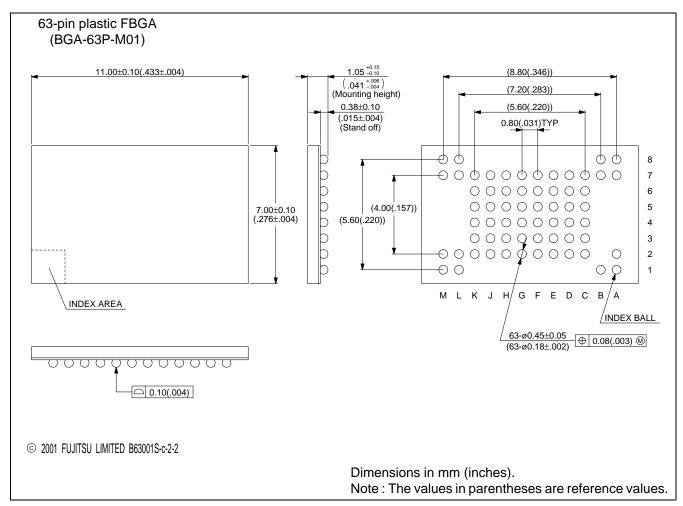


#### **■** ORDERING INFORMATION

Part No.	Package	Access Time (ns)	Sector Architecture
MBM29PDS322TE10PBT	63-pin plastic FBGA	100	Top sector
MBM29PDS322TE11PBT	(BGA-63P-M01)	115	
MBM29PDS322BE10PBT	63-pin plastic FBGA	100	Bottom sector
MBM29PDS322BE11PBT	(BGA-63P-M01)	115	



#### **■ PACKAGE DIMENSION**



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